

TEST REPORT

FCC LTE B71 Test for SM-A376U
Certification

APPLICANT
SAMSUNG Electronics Co., Ltd.

REPORT NO.
HCT-RF-2512-FC021

DATE OF ISSUE
December 15, 2025

Tested by
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TEST REPORT

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HCT-RF-2512-FC021

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Additional Model

SM-A376U1, SM-S376V

Applicant**SAMSUNG Electronics Co., Ltd.**

129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea

Product Name

Mobile Phone

Model Name

SM-A376U

Date of Test

October 29, 2025 ~ December 15, 2025

FCC ID

A3LSMA376U

Location of Test

☒ Permanent Testing Lab ☐ On Site Testing

(Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, Republic of Korea)

FCC Classification:

PCS Licensed Transmitter Held to Ear (PCE)

Test Standard Used

FCC Rule Part: § 27

Test Results

PASS

REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	December 15, 2025	Initial Release

Notice

Content
The measurements shown in this report were made in accordance with the procedures specified in CFR47 section § 2.947. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them. HCT CO., LTD. Certifies that no party to this application has subject to a denial of Federal benefits that includes FCC benefits pursuant to section 5301 of the Anti-Drug Abuse Act of 1998,21 U.S. C.853(a) The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated. The test results have only been applied with the test methods required by the standard(s). The laboratory is not accredited for the test results marked *. Information provided by the applicant is marked **. Test results provided by external providers are marked ***. When confirmation of authenticity of this test report is required, please contact www.hct.co.kr The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

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MEASUREMENT REPORT

1. GENERAL INFORMATION

Model(s):	SM-A376U
Additional Model(s)	SM-A376U1, SM-S376V
Tx Frequency:	665.5 MHz – 695.5 MHz (LTE – Band 71 (5 MHz)) 668.0 MHz – 693.0 MHz (LTE – Band 71 (10 MHz)) 670.5 MHz – 690.5 MHz (LTE – Band 71 (15 MHz)) 673.0 MHz – 688.0 MHz (LTE – Band 71 (20 MHz))
Serial number:	Radiated : R3CY90Z81WA Conducted : R3CY90Z7ZQA
Antenna Information	Please refer to the Antenna Specification document.

1.1 MAXIMUM OUTPUT POWER

Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	ERP	
				Max. Power (W)	Max. Power (dBm)
LTE – Band71 (5)	665.5 - 695.5	4M54G7D	QPSK	0.096	19.82
		4M52W7D	16-QAM	0.081	19.10
		4M52W7D	64-QAM	0.062	17.92
		4M53W7D	256-QAM	0.031	14.90
LTE – Band71 (10)	668.0 - 693.0	9M02G7D	QPSK	0.095	19.80
		8M99W7D	16-QAM	0.081	19.06
		9M01W7D	64-QAM	0.063	17.98
		9M02W7D	256-QAM	0.031	14.95
LTE – Band71 (15)	670.5 - 690.5	13M5G7D	QPSK	0.099	19.94
		13M5W7D	16-QAM	0.082	19.15
		13M5W7D	64-QAM	0.064	18.03
		13M5W7D	256-QAM	0.032	15.02
LTE – Band71 (20)	673.0 - 688.0	18M0G7D	QPSK	0.103	20.12
		18M0W7D	16-QAM	0.084	19.24
		17M9W7D	64-QAM	0.066	18.18
		18M0W7D	256-QAM	0.033	15.23

2. INTRODUCTION

2.1. DESCRIPTION OF EUT

Please refer to the [2G3G] Test Report.

2.2. MEASURING INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturer's recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

2.3. TEST FACILITY

The Fully-anechoic chamber and conducted measurement facility used to collect the radiated data are located at the 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, Republic of Korea.

Detailed description of test facility was submitted to the Commission and accepted dated March 11, 2024 (Registration Number: KR0032).

2.4. EQUIPMENT

Radiated emissions are measured with one or more of the following types of Linearly polarized antennas: tuned dipole, bi-conical, log periodic, bi-log, and/or ridged waveguide, horn. Spectrum analyzers with pre-selectors and quasi-peak detectors are used to perform radiated measurements.

Conducted emissions are measured with Line Impedance Stabilization Networks and EMI Test Receivers.

Calibrated wideband preamplifiers, coaxial cables, and coaxial attenuators are also used for making measurements.

All receiving equipment conforms to ANSI/USEMCSC C63.2-2023, "American National Standard for Specifications of Electromagnetic Interference and Field Strength Measuring Instrumentation in the Frequency Range 9 kHz to 40 GHz".

3. DESCRIPTION OF TESTS

3.1 TEST PROCEDURE

Test Description	Test Procedure Used
Occupied Bandwidth	- KDB 971168 D01 v03r01 – Section 4.3 - ANSI C63.26-2015 – Section 5.4.4
Band Edge	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Spurious and Harmonic Emissions at Antenna Terminal	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Conducted Output Power	- KDB 971168 D01 v03r01 - Section 5.2.4 - ANSI C63.26-2015 - Section 5.2.1 & 5.2.4.2
Peak- to- Average Ratio	- KDB 971168 D01 v03r01 – Section 5.7 - ANSI C63.26-2015 – Section 5.2.3.4
Frequency stability	- ANSI C63.26-2015 – Section 5.6
Radiated Power	- ANSI C63.26-2015 – Section 5.2.4.4 - KDB 971168 D01 v03r01 – Section 5.8
Radiated Spurious and Harmonic Emissions	- ANSI C63.26-2015 – Section 5.5.3 - KDB 971168 D01 v03r01 – Section 5.8

3.2 RADIATED POWER

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

The equipment under test is placed on a non-conductive table 3-meters away from the receive antenna.

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
2. RBW = 1 – 5 % of the expected OBW, not to exceed 1 MHz
3. VBW $\geq$ 3 x RBW
4. Span = 1.5 times the OBW
5. No. of sweep points > 2 x span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

Test Note

1. The turntable is rotated through 360 degrees, and the receiving antenna scans in order to determine the level of the maximized emission.
2. A half wave dipole is then substituted in place of the EUT. For emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.

The power is calculated by the following formula;

$$P_d \text{ (dBm)} = P_g \text{ (dBm)} - \text{cable loss (dB)} + \text{antenna gain (dB)}$$

Where: P_d is the dipole equivalent power and P_g is the generator output power into the substitution antenna.

3. The maximum value is calculated by adding the forward power to the calibrated source plus its appropriate gain value.

These steps are repeated with the receiving antenna in both vertical and horizontal polarization. the difference between the gain of the horn and an isotropic antenna are taken into consideration

4. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
5. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

3.3 RADIATED SPURIOUS EMISSIONS

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

Radiated Spurious Emission Measurements at 3 meters by Substitution Method.

Test Settings

1. RBW = 100 kHz for emissions below 1 GHz and 1 MHz for emissions above 1 GHz
2. VBW $\geq$ 3 x RBW
3. No. of sweep points > 2 x span / RBW
4. Detector = Peak
5. Trace mode = Max Hold
6. The trace was allowed to stabilize
7. Test channel : Low/ Middle/ High
8. Frequency range : We are performed all frequency to 10th harmonics from 9 kHz.

Test Note

1. Measurements value show only up to 3 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.
2. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the test data
3. For spurious emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated. The spurious emissions is calculated by the following formula;

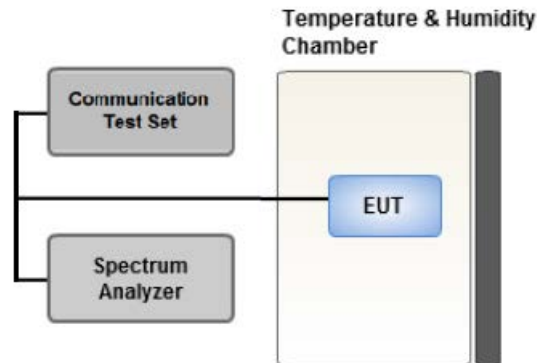
$$\text{Result}_{(\text{dBm})} = P_g_{(\text{dBm})} - \text{cable loss}_{(\text{dB})} + \text{antenna gain}_{(\text{dBi})}$$

Where: P_g is the generator output power into the substitution antenna.

If the fundamental frequency is below 1 GHz, RF output power has been converted to EIRP.

$$\text{EIRP}_{(\text{dBm})} = \text{ERP}_{(\text{dBm})} + 2.15$$

3.4 OCCUPIED BANDWIDTH.



Test setup

The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

The EUT makes a call to the communication simulator.

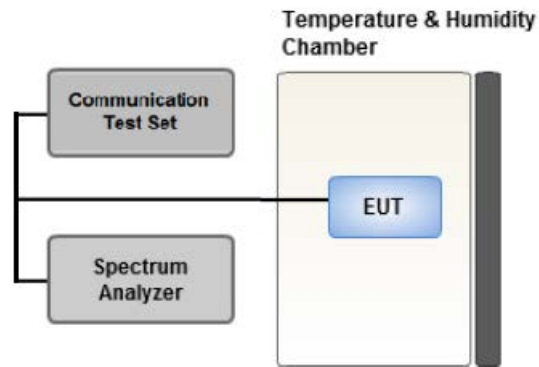
The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99 % occupied bandwidth and the 26 dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. $RBW = 1 - 5 \%$ of the expected OBW
3. $VBW \geq 3 \times RBW$
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within $1 - 5 \%$ of the 99 % occupied bandwidth observed in Step 7

3.5 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL



Test setup

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic.

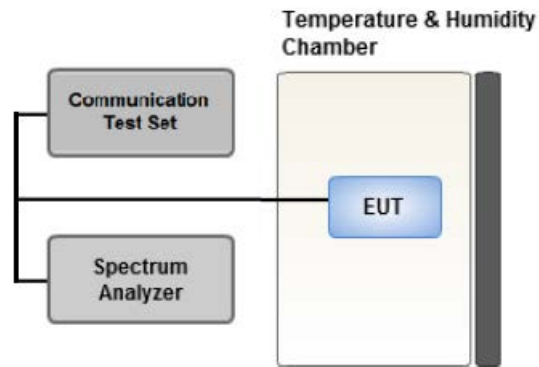
All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. RBW = 1 MHz
2. VBW $\geq$ 3 MHz
3. Detector = Peak
4. Trace Mode = max hold
5. Sweep time = auto
6. Number of points in sweep $\geq 2 \times \text{Span} / \text{RBW}$

3.6 BAND EDGE



Test setup

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW > 1 % of the emission bandwidth
4. VBW > 3 x RBW
5. Detector = RMS
6. Number of sweep points $\geq 2 \times \text{Span/RBW}$
7. Trace mode = trace average
8. Sweep time > (Number of Points) $\times$ (Symbol Period)
9. The trace was allowed to stabilize

Test Notes

According to FCC 22.917, 24.238, 27.53 specified that power of any emission outside of The authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

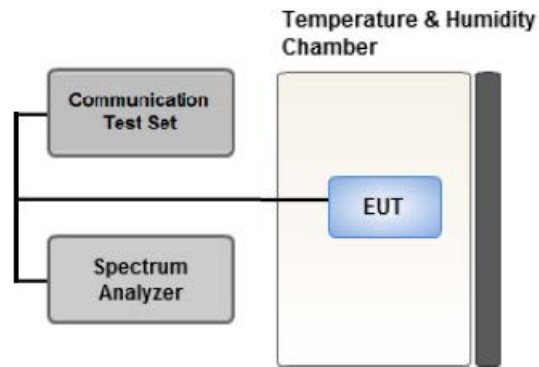
In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

All measurements were done at 2 channels(low and high operational frequency range.)

The band edge measurement used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

Where $\text{Margin} < 1$ dB the emission level is either corrected by $10 \log(1 \text{ MHz} / \text{RB})$ or the emission is integrated over a 1 MHz bandwidth to determine the final result. When using the integration method the integration window is either centered on the emission or, for emissions at the band edge, centered by an offset of 500 kHz from the block edge so that the integration window is the 1 MHz adjacent to the block edge.

3.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE



Test setup

Test Overview

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015.

The frequency stability of the transmitter is measured by:

1. Temperature:

The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.

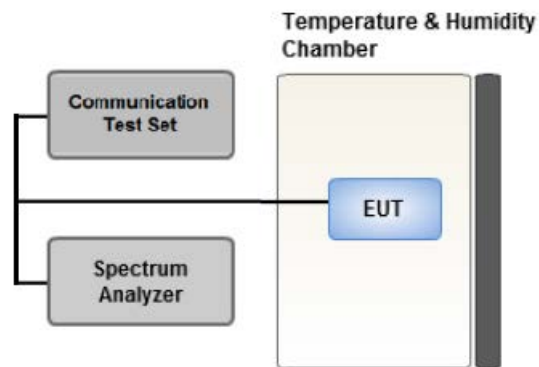
2. Primary Supply Voltage:

- .- Unless otherwise specified, vary primary supply voltage from 85 % to 115 % of the nominal value for other than hand carried battery equipment.
- .- For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10 °C intervals ranging from -30 °C to +50 °C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

3.8 PEAK- TO- AVERAGE RATIO



Test setup

Test Settings

1. Set resolution/measurement bandwidth $\geq$ signal's occupied bandwidth;
2. Set the number of counts to a value that stabilizes the measured CCDF curve;
3. Set the measurement interval as follows:
 - .- for continuous transmissions, set to 1 ms,
 - .- or burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
4. Record the maximum PAPR level associated with a probability of 0.1 %.

3.9 WORST CASE(RADIATED TEST)

- The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
- All modes of operation were investigated and the worst case configuration results are reported.
Mode : Stand alone, Stand alone + External accessories (Earphone, AC adapter, etc)
Worst case : Stand alone
- All simultaneous transmission scenarios of operation were investigated, and the test results showed no additional significant emissions relative to the least restrictive limit were observed.
Therefore, only the worst case(stand-alone) results were reported.
- In the case of radiated spurious emissions, all bandwidth of operation were investigated and the worst case bandwidth results are reported. (Worst case : 20 MHz)
- The worst case is reported with the EUT positioning, modulations, and paging service configurations shown in the test data
- Please refer to the table below.
- SM-A376U & additional models were tested and the worst case results are reported.
(Worst case : SM-A376U)

[Worst case]

Test Description	Modulation	RB size	RB offset	Axis
Effective Radiated Power	QPSK, 16QAM, 64QAM, 256QAM	See Section 8.1		Z
Radiated Spurious and Harmonic Emissions	QPSK	See Section 8.2		Z

3.10 WORST CASE(CONDUCTED TEST)

- All modes of operation were investigated and the worst case configuration results are reported.
 - SM-A376U & additional models were tested and the worst case results are reported.
- (Worst case : SM-A376U)

[Worst case]

Test Description	Modulation	Bandwidth (MHz)	Frequency	RB size	RB offset
Occupied Bandwidth	QPSK, 16QAM, 64QAM, 256QAM	5,10,15,20	Mid	Full RB	0
Band Edge	QPSK	5	Low	1	0
			High	1	24
		10	Low	1	0
			High	1	49
		15	Low	1	0
			High	1	74
		20	Low	1	0
			High	1	99
		5,10,15,20	Low, High	Full RB	0
Spurious and Harmonic Emissions at Antenna Terminal	QPSK	5,10,15,20	Low, Mid, High	1	0

4. LIST OF TEST EQUIPMENT

Equipment	Model	Manufacture	Serial No.	Due to Calibration	Calibration Interval
RF Switching System	Switch box(1 G HPF+LNA)	HCT CO., LTD.,	F2L2	12/01/2026	Annual
RF Switching System	Switch box(3 G HPF+LNA)	HCT CO., LTD.,	F2L3	12/01/2026	Annual
RF Switching System	Switch box(LNA)	HCT CO., LTD.,	F2L5	12/01/2026	Annual
RF Switching System	Switch box(6 G HPF+LNA)	HCT CO., LTD.,	F2L14	12/01/2026	Annual
Power Amplifier	CBL18265035	CERNEX	22966	10/21/2026	Annual
Power Amplifier	CBL26405040	CERNEX	25956	02/19/2026	Annual
Power Splitter(DC ~ 26.5 GHz)	11667B	Hewlett Packard	5001	04/10/2026	Annual
DC Power Supply	E3632A	Agilent	MY40010147	07/29/2026	Annual
Dipole Antenna	UHAP	Schwarzbeck	01274	03/10/2026	Biennial
Dipole Antenna	UHAP	Schwarzbeck	01288	08/07/2026	Biennial
Chamber	SU-642	ESPEC	93008124	02/11/2026	Annual
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	03197	11/28/2026	Biennial
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	03201	11/28/2026	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170342	09/20/2026	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170124	03/23/2027	Biennial
Signal Analyzer(10 Hz ~ 26.5 GHz)	N9020A	Agilent	MY52090906	04/14/2026	Annual
ATTENUATOR(20 dB)	8493C	Hewlett Packard	17280	04/10/2026	Annual
Spectrum Analyzer(10 Hz ~ 40 GHz)	FSV40	ROHDE & SCHWARZ	101733	09/17/2026	Annual
Base Station	8960 (E5515C)	Agilent	MY48360800	07/29/2026	Annual
Loop Antenna(9 kHz ~ 30 MHz)	FMZB1513	Schwarzbeck	1513-333	03/07/2026	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	895	08/28/2026	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	1135	08/19/2026	Biennial
Radio Communication Test Station	MT8000A	Anritsu Corp.	6272613402	08/18/2026	Annual
SIGNAL GENERATOR (100 kHz ~ 40 GHz)	SMB100A	REOHDE & SCHWARZ	177633	07/22/2026	Annual
Signal Analyzer(5 Hz ~ 40.0 GHz)	N9030B	KEYSIGHT	MY55480167	05/14/2026	Annual
UXM 5G Wireless Test Platform	E7515B	KEYSIGHT	MY60101126	02/10/2026	Annual
Automation Software	FCC 2G/3G/4G Conducted	HCT CO., LTD	-	-	-
Automation Software	FCC NR Conducted	HCT CO., LTD	-	-	-
Automation Software	FCC LTE Radiated	HCT CO., LTD	-	-	-
Automation Software	FCC NR Radiated	HCT CO., LTD	-	-	-

Note:

- Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
- The RF Switching System was not used for testing on its calibration date (12/01/2025). The next due date for calibration has been updated to 12/01/2026.
- Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5-2017.

5. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014.

All measurement uncertainty values are shown with a coverage factor of $k=2$ to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded Uncertainty ($\pm$ kHz)
Occupied Bandwidth	95 (Confidence level about 95 %, $k=2$)
Frequency stability	28 (Confidence level about 95 %, $k=2$)
Parameter	Expanded Uncertainty ($\pm$ kHz)
Block Edge	0.70 (Confidence level about 95 %, $k=2$)
Conducted Spurious Emissions	1.18 (Confidence level about 95 %, $k=2$)
Peak- to- Average Ratio	0.68 (Confidence level about 95 %, $k=2$)
Radiated Power	4.74 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.36 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.68 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.75 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.82 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (Above 40 GHz)	5.58 (Confidence level about 95 %, $k=2$)

6. SUMMARY OF TEST RESULTS

-. The decision rule applies 'simple acceptance'

6.1 Test Condition: Conducted Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Occupied Bandwidth	§ 2.1049	N/A	PASS
Band Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§ 2.1051, § 27.53(g)	< 43 + 10log10 (P[Watts]) at Band Edge and for all out-of-band emissions	PASS
Conducted Output Power	§ 2.1046	N/A	PASS <u>Note1</u>
Frequency stability / variation of ambient temperature	§ 2.1055, § 27.54	Emission must remain in band	PASS

Note:

1. Refer to the SAR report.

6.2 Test Condition: Radiated Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Effective Radiated Power	§ 27.50(c)(10)	< 3 Watts max. ERP	PASS
Radiated Spurious and Harmonic Emissions	§ 2.1053, § 27.53(g)	< 43 + 10log10 (P[Watts]) for all out-of band emissions	PASS

7. SAMPLE CALCULATION

7.1 ERP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol.	ERP	
channel	Freq.(MHz)						W	dBm
128	824.20	-21.37	38.40	-10.61	0.95	H	0.483	26.84

$$\text{ERP} = \text{Substitute LEVEL(dBm)} + \text{Ant. Gain} - \text{CL(Cable Loss)}$$

- 1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
- 2) During the test, the turn table is rotated until the maximum signal is found.
- 3) Record the field strength meter's level.
- 4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
- 5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
- 6) The signal generator output level with Ant. Gain and cable loss are the rating of effective radiated power.

7.2 EIRP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBi)	C.L	Pol.	EIRP	
channel	Freq.(MHz)						W	dBm
20175	1,732.50	-15.75	18.45	9.90	1.76	H	0.456	26.59

$$\text{EIRP} = \text{Substitute LEVEL(dBm)} + \text{Ant. Gain} - \text{CL(Cable Loss)}$$

- 1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
- 2) During the test, the turn table is rotated until the maximum signal is found.
- 3) Record the field strength meter's level.
- 4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
- 5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
- 6) The signal generator output level with Ant. Gain and cable loss are the rating of equivalent isotropic radiated power.

7.3. Emission Designator

GSM Emission Designator

Emission Designator = 249KGXW
GSM BW = 249 kHz
G = Phase Modulation
X = Cases not otherwise covered
W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 249KG7W
GSM BW = 249 kHz
G = Phase Modulation
7 = Quantized/Digital Info
W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M17F9W
WCDMA BW = 4.17 MHz
F = Frequency Modulation
9 = Composite Digital Info
W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 4M48G7D
LTE BW = 4.48 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

QAM Modulation

Emission Designator = 4M48W7D
LTE BW = 4.48 MHz
W = Amplitude/Angle Modulated
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

8. TEST DATA

8.1 EFFECTIVE RADIATED POWER

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
665.5	LTE B71 (5 MHz)	QPSK	-29.06	29.13	-9.65	1.25	H	< 3.00	0.067	18.23	1	0
		16-QAM	-29.80	28.39	-9.65	1.25	H		0.056	17.49		
		64-QAM	-30.93	27.26	-9.65	1.25	H		0.043	16.36		
		256-QAM	-33.86	24.33	-9.65	1.25	H		0.022	13.43		
680.5		QPSK	-29.15	30.30	-9.65	1.28	H		0.086	19.37	1	0
		16-QAM	-29.88	29.57	-9.65	1.28	H		0.073	18.64		
		64-QAM	-31.06	28.39	-9.65	1.28	H		0.056	17.46		
		256-QAM	-34.06	25.39	-9.65	1.28	H		0.028	14.46		
695.5		QPSK	-29.41	30.76	-9.65	1.29	H		0.096	19.82	1	0
		16-QAM	-30.13	30.04	-9.65	1.29	H		0.081	19.10		
		64-QAM	-31.31	28.86	-9.65	1.29	H		0.062	17.92		
		256-QAM	-34.33	25.84	-9.65	1.29	H		0.031	14.90		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured	Substitute	Ant.	C.L	Pol	Limit	ERP		RB	
			Level (dBm)	Level (dBm)	Gain (dBd)			W	W	dBm	Size	Offset
668.0	LTE B71 (10 MHz)	QPSK	-28.91	29.33	-9.65	1.26	H	< 3.00	0.070	18.42	1	49
		16-QAM	-29.72	28.52	-9.65	1.26	H		0.058	17.61		
		64-QAM	-30.73	27.51	-9.65	1.26	H		0.046	16.60		
		256-QAM	-33.78	24.46	-9.65	1.26	H		0.023	13.55		
680.5		QPSK	-29.10	30.35	-9.65	1.28	H		0.087	19.42	1	0
		16-QAM	-30.08	29.37	-9.65	1.28	H		0.070	18.44		
		64-QAM	-31.03	28.42	-9.65	1.28	H		0.056	17.49		
		256-QAM	-33.93	25.52	-9.65	1.28	H		0.029	14.59		
693.0		QPSK	-29.52	30.74	-9.65	1.29	H		0.095	19.80	1	25
		16-QAM	-30.26	30.00	-9.65	1.29	H		0.081	19.06		
		64-QAM	-31.34	28.92	-9.65	1.29	H		0.063	17.98		
		256-QAM	-34.37	25.89	-9.65	1.29	H		0.031	14.95		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
670.5	LTE B71 (15 MHz)	QPSK	-28.99	29.41	-9.65	1.26	H	< 3.00	0.071	18.50	1	38
		16-QAM	-29.68	28.72	-9.65	1.26	H		0.060	17.81		
		64-QAM	-30.79	27.61	-9.65	1.26	H		0.047	16.70		
		256-QAM	-33.78	24.62	-9.65	1.26	H		0.023	13.71		
680.5		QPSK	-28.92	30.53	-9.65	1.28	H		0.091	19.60	1	0
		16-QAM	-29.76	29.69	-9.65	1.28	H		0.075	18.76		
		64-QAM	-30.85	28.60	-9.65	1.28	H		0.058	17.67		
		256-QAM	-33.85	25.60	-9.65	1.28	H		0.029	14.67		
690.5		QPSK	-29.36	30.88	-9.65	1.29	H		0.099	19.94	1	38
		16-QAM	-30.15	30.09	-9.65	1.29	H		0.082	19.15		
		64-QAM	-31.27	28.97	-9.65	1.29	H		0.064	18.03		
		256-QAM	-34.28	25.96	-9.65	1.29	H		0.032	15.02		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
673.0	LTE B71 (20 MHz)	QPSK	-29.00	29.54	-9.65	1.27	H	< 3.00	0.073	18.62	1	50
		16-QAM	-29.80	28.74	-9.65	1.27	H		0.061	17.82		
		64-QAM	-30.86	27.68	-9.65	1.27	H		0.047	16.76		
		256-QAM	-33.87	24.67	-9.65	1.27	H		0.024	13.75		
680.5		QPSK	-28.95	30.50	-9.65	1.28	H		0.091	19.57	1	0
		16-QAM	-29.76	29.69	-9.65	1.28	H		0.075	18.76		
		64-QAM	-30.97	28.48	-9.65	1.28	H		0.057	17.55		
		256-QAM	-33.85	25.60	-9.65	1.28	H		0.029	14.67		
688.0		QPSK	-29.13	31.06	-9.65	1.29	H		0.103	20.12	1	0
		16-QAM	-30.01	30.18	-9.65	1.29	H		0.084	19.24		
		64-QAM	-31.07	29.12	-9.65	1.29	H		0.066	18.18		
		256-QAM	-34.02	26.17	-9.65	1.29	H		0.033	15.23		

8.2 RADIATED SPURIOUS EMISSIONS

■ MODE: LTE B71
 ■ MODULATION SIGNAL: 20 MHz QPSK
 ■ DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
133222 (673.0)	1 346.00	-48.41	7.14	-60.24	1.77	V	-54.87	-13.00	1	50
	2 019.00	-51.70	9.41	-64.15	2.23	H	-56.97	-13.00		
	2 692.00	-52.75	10.61	-63.88	2.60	V	-55.87	-13.00		
	3 365.00	-53.40	11.13	-62.30	2.96	V	-54.13	-13.00		
	4 038.00	-49.03	11.47	-55.39	3.25	H	-47.17	-13.00		
133297 (680.5)	1 361.00	-48.01	7.31	-60.00	1.81	V	-54.50	-13.00	1	0
	2 041.50	-50.89	9.46	-62.82	2.25	V	-55.61	-13.00		
	2 722.00	-53.26	10.61	-64.16	2.60	V	-56.15	-13.00		
	3 402.50	-53.18	11.23	-62.03	2.97	V	-53.77	-13.00		
	4 083.00	-48.28	11.57	-54.52	3.32	V	-46.27	-13.00		
133372 (688.0)	1 376.00	-49.25	7.48	-61.67	1.85	V	-56.04	-13.00	1	0
	2 064.00	-52.59	9.49	-64.05	2.29	H	-56.85	-13.00		
	2 752.00	-54.14	10.57	-64.97	2.70	H	-57.10	-13.00		
	3 440.00	-53.84	11.41	-62.73	3.04	H	-54.36	-13.00		
	4 128.00	-51.59	11.68	-57.87	3.33	V	-49.52	-13.00		

8.3 PEAK-TO-AVERAGE RATIO

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (dB)	Limit (dB)
71	5 MHz	680.5	QPSK	25	0	5.14	13.00
			16-QAM			5.81	
			64-QAM			6.07	
			256-QAM			6.48	
	10 MHz		QPSK	50		5.26	
			16-QAM			5.87	
			64-QAM			6.19	
			256-QAM			6.52	
	15 MHz		QPSK	75		5.20	
			16-QAM			5.83	
			64-QAM			6.11	
			256-QAM			6.46	
	20 MHz		QPSK	100		5.04	
			16-QAM			5.72	
			64-QAM			6.07	
			256-QAM			6.48	

Note:

1. Plots of the EUT's P.A.P.R are shown Page 43 ~ 58.
2. P.A.P.R is not required. These values are reported for information only.

8.4 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
71	5 MHz	680.5	QPSK	25	0	4.5351
			16-QAM			4.5176
			64-QAM			4.5182
			256-QAM			4.5340
	10 MHz		QPSK	50		9.0209
			16-QAM			8.9893
			64-QAM			9.0051
			256-QAM			9.0243
	15 MHz		QPSK	75		13.471
			16-QAM			13.471
			64-QAM			13.485
			256-QAM			13.458
	20 MHz		QPSK	100		18.031
			16-QAM			17.952
			64-QAM			17.937
			256-QAM			17.962

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 59 ~ 74.

8.5 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
71	5	665.5	3.6990	27.976	-57.715	-29.739	-13.00
		680.5	6.5404	28.591	-57.674	-29.083	
		695.5	3.6990	27.976	-57.996	-30.020	
	10	668.0	3.7089	27.976	-56.759	-28.783	
		680.5	3.1905	27.976	-57.894	-29.918	
		693.0	3.1706	27.976	-58.322	-30.346	
	15	670.5	3.1805	27.976	-57.748	-29.772	
		680.5	3.2902	27.976	-58.280	-30.304	
		690.5	3.6890	27.976	-57.668	-29.692	
	20	673.0	5.6531	28.591	-57.731	-29.140	
		680.5	3.6790	27.976	-57.893	-29.917	
		688.0	5.5733	28.591	-57.498	-28.907	

Note:

1. Plots of the EUT's Conducted Spurious Emissions are shown Page 75 ~ 86.
2. Conducted Spurious Emissions was Tested QPSK Modulation, Resource Block Size 1 and Resource Block Offset 0
3. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
4. Factor (dB) = Cable Loss + Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 – 1	25.270
1 – 5	27.976
5 – 10	28.591
10 – 15	29.116
15 – 20	29.489
Above 20(26.5)	30.131

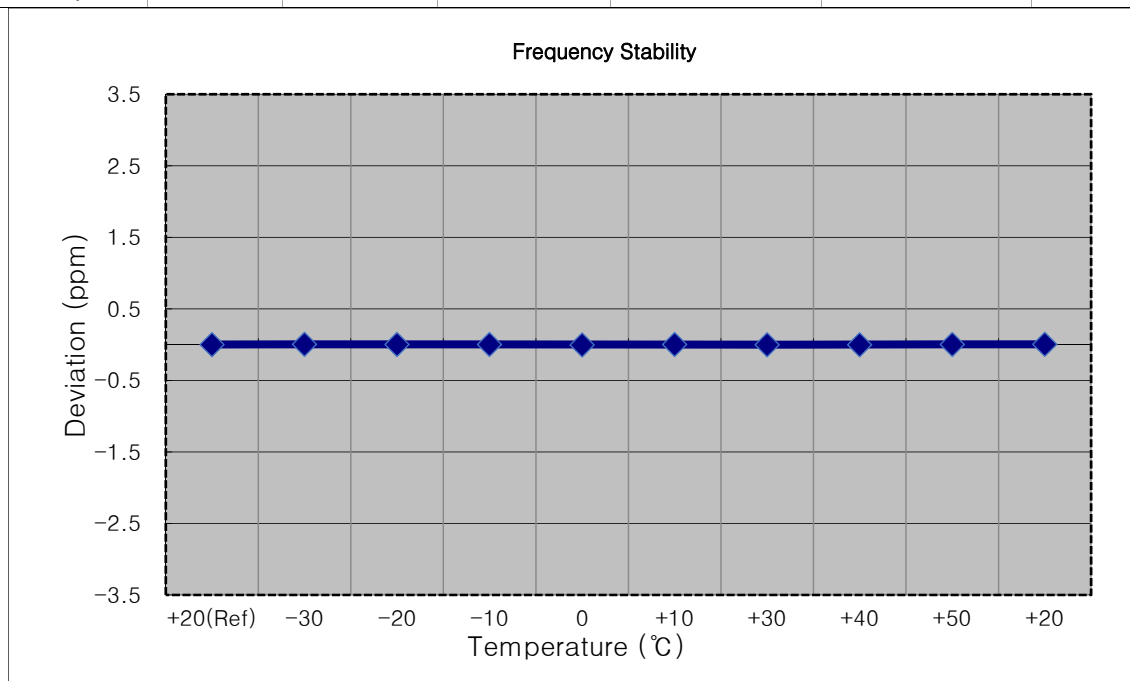
8.6 BAND EDGE

- Plots of the EUT's Band Edge are shown Page 87 ~ 110.

8.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

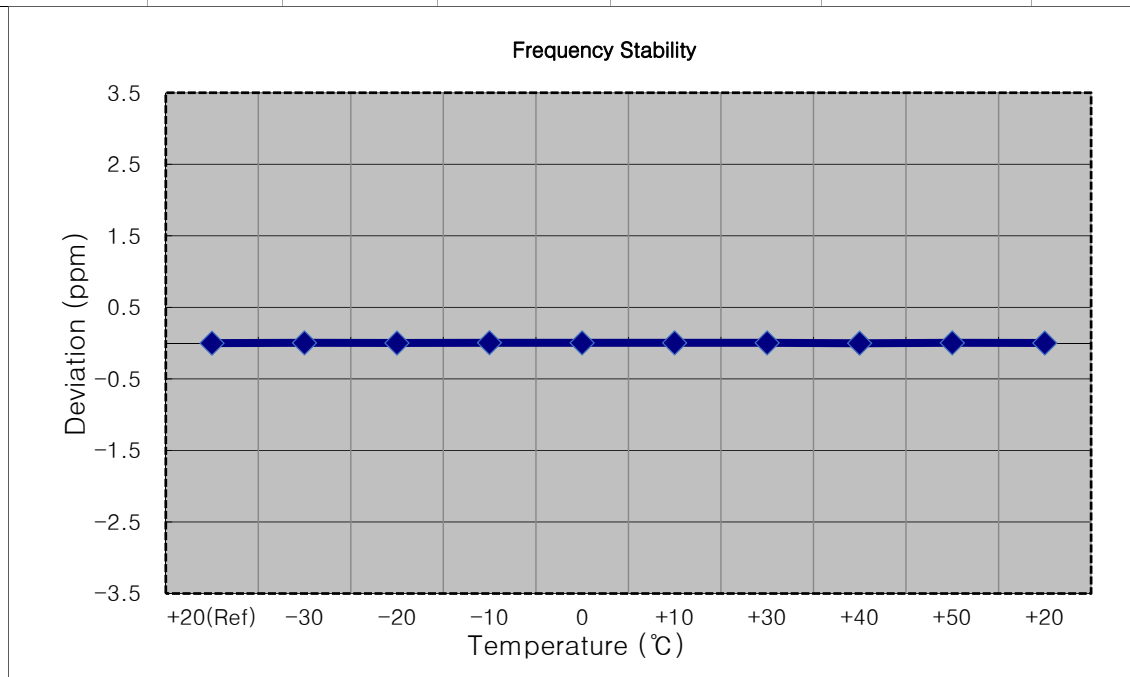
MODE:	<u>LTE B71</u>
OPERATING FREQUENCY:	<u>665,500,000 Hz</u>
CHANNEL:	<u>133147 (5 MHz)</u>
REFERENCE VOLTAGE:	<u>3.900 VDC</u>
DEVIATION LIMIT:	<u>Emission must remain in band</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	665 500 002	0.0	0.000 000	0.000
100 %		-30	665 500 005	2.8	0.000 000	0.004
100 %		-20	665 500 004	2.0	0.000 000	0.003
100 %		-10	665 500 003	1.5	0.000 000	0.002
100 %		0	665 500 000	-2.0	0.000 000	-0.003
100 %		+10	665 500 004	2.2	0.000 000	0.003
100 %		+30	665 500 000	-1.7	0.000 000	-0.003
100 %		+40	665 500 001	-1.4	0.000 000	-0.002
100 %		+50	665 500 004	1.7	0.000 000	0.003
Batt. Endpoint	3.400	+20	665 500 005	2.8	0.000 000	0.004



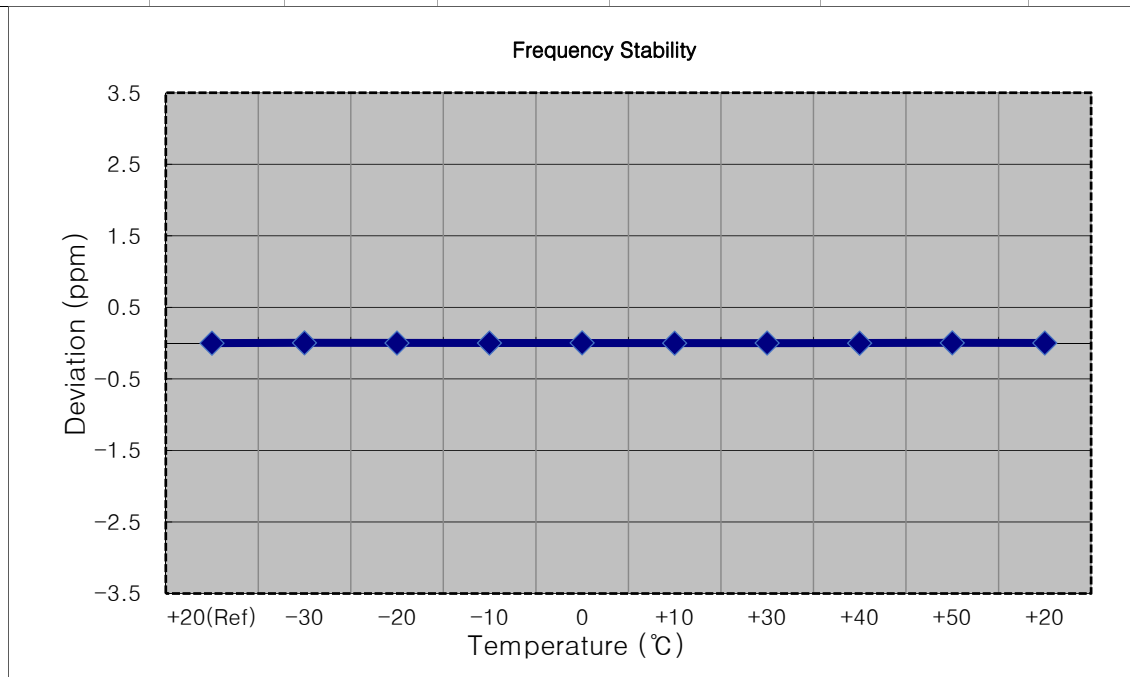
MODE: LTE B71
 OPERATING FREQUENCY: 668,000,000 Hz
 CHANNEL: 133172 (10 MHz)
 REFERENCE VOLTAGE: 3.900 VDC
 DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	668 000 003	0.0	0.000 000	0.000
100 %		-30	668 000 005	2.1	0.000 000	0.003
100 %		-20	668 000 005	1.5	0.000 000	0.002
100 %		-10	668 000 006	3.2	0.000 000	0.005
100 %		0	668 000 006	3.0	0.000 000	0.004
100 %		+10	668 000 006	2.6	0.000 000	0.004
100 %		+30	668 000 006	2.6	0.000 000	0.004
100 %		+40	668 000 002	-1.3	0.000 000	-0.002
100 %		+50	668 000 006	2.6	0.000 000	0.004
Batt. Endpoint	3.400	+20	668 000 005	1.5	0.000 000	0.002



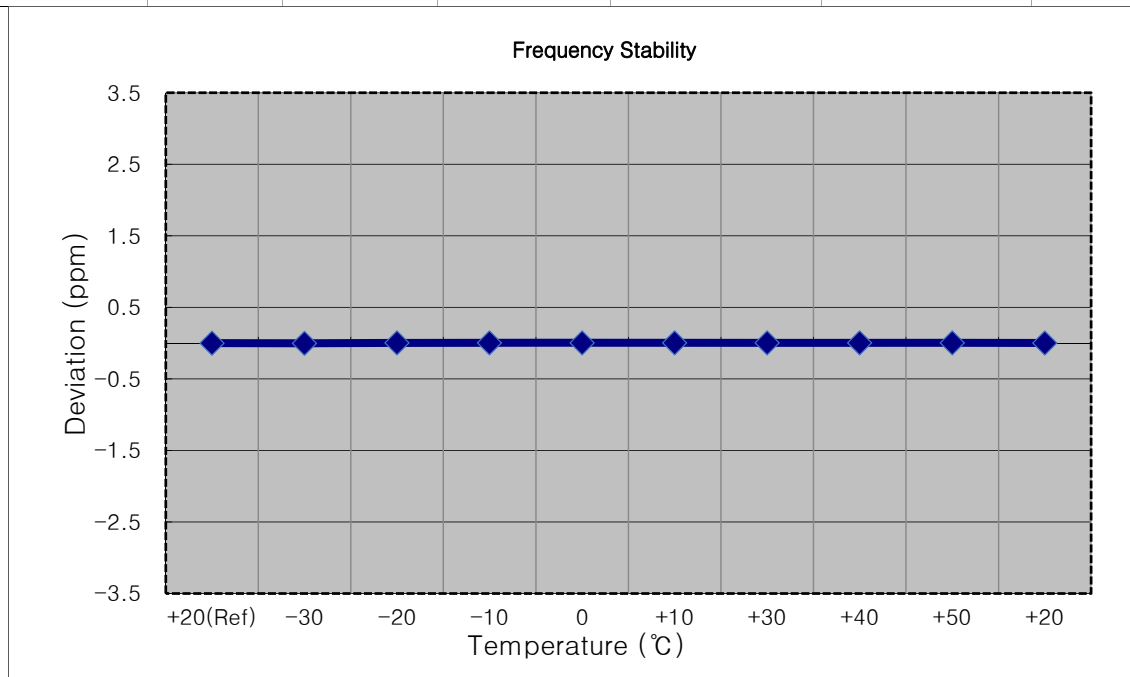
MODE: LTE B71
 OPERATING FREQUENCY: 670,500,000 Hz
 CHANNEL: 133197 (15 MHz)
 REFERENCE VOLTAGE: 3.900 VDC
 DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	670 500 001	0.0	0.000 000	0.000
100 %		-30	670 500 003	1.7	0.000 000	0.003
100 %		-20	670 500 003	1.5	0.000 000	0.002
100 %		-10	670 500 003	1.6	0.000 000	0.002
100 %		0	670 500 004	2.3	0.000 000	0.003
100 %		+10	670 500 000	-1.2	0.000 000	-0.002
100 %		+30	670 500 003	1.3	0.000 000	0.002
100 %		+40	670 500 001	-0.8	0.000 000	-0.001
100 %		+50	670 500 003	2.0	0.000 000	0.003
Batt. Endpoint	3.400	+20	670 500 003	1.1	0.000 000	0.002



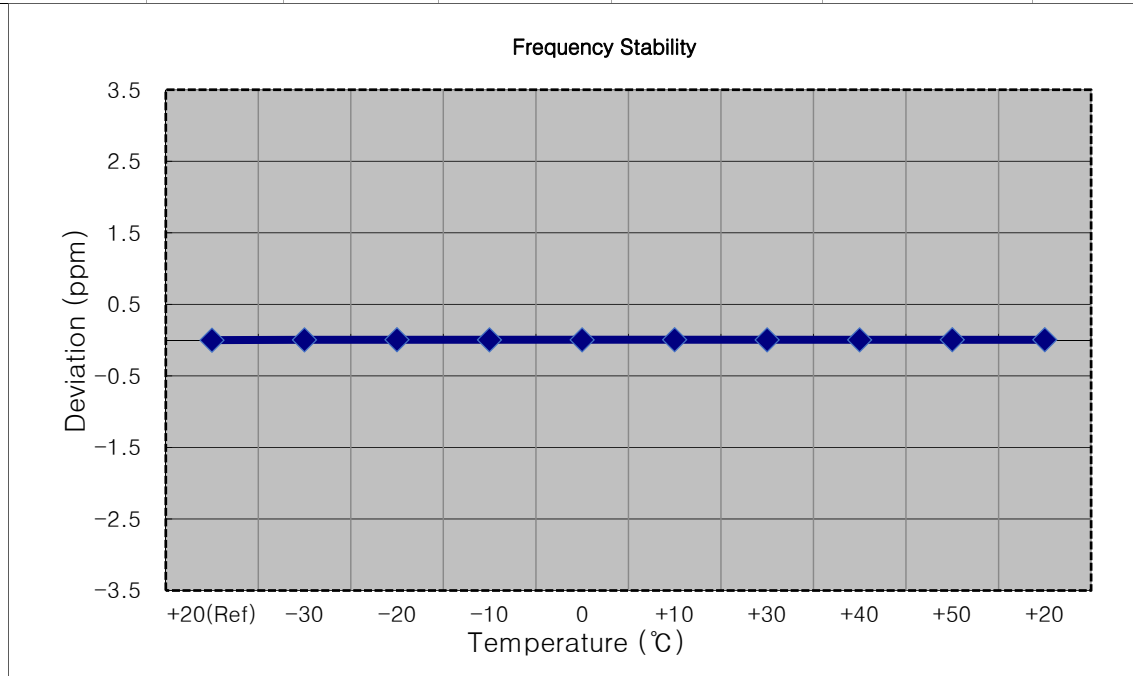
MODE:	<u>LTE B71</u>
OPERATING FREQUENCY:	<u>673,000,000 Hz</u>
CHANNEL:	<u>133222 (20 MHz)</u>
REFERENCE VOLTAGE:	<u>3.900 VDC</u>
DEVIATION LIMIT:	<u>Emission must remain in band</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	672 999 999	0.0	0.000 000	0.000
100 %		-30	672 999 997	-1.8	0.000 000	-0.003
100 %		-20	673 000 001	2.2	0.000 000	0.003
100 %		-10	673 000 001	1.9	0.000 000	0.003
100 %		0	673 000 001	2.3	0.000 000	0.003
100 %		+10	673 000 001	2.3	0.000 000	0.003
100 %		+30	673 000 001	2.2	0.000 000	0.003
100 %		+40	673 000 001	2.0	0.000 000	0.003
100 %		+50	673 000 002	2.9	0.000 000	0.004
Batt. Endpoint	3.400	+20	673 000 000	1.4	0.000 000	0.002



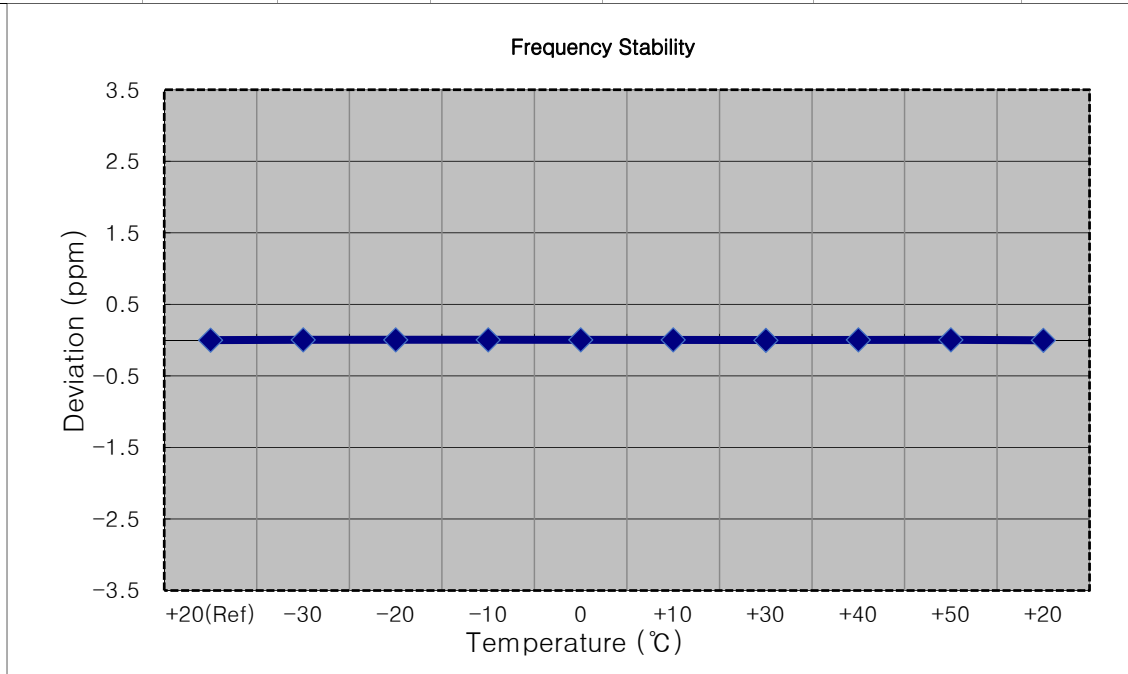
MODE:	<u>LTE B71</u>
OPERATING FREQUENCY:	<u>680,500,000 Hz</u>
CHANNEL:	<u>133297 (5 MHz)</u>
REFERENCE VOLTAGE:	<u>3.900 VDC</u>
DEVIATION LIMIT:	<u>Emission must remain in band</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	680 500 003	0.0	0.000 000	0.000
100 %		-30	680 500 006	3.1	0.000 000	0.005
100 %		-20	680 500 006	3.5	0.000 001	0.005
100 %		-10	680 500 005	2.4	0.000 000	0.004
100 %		0	680 500 005	2.5	0.000 000	0.004
100 %		+10	680 500 006	3.4	0.000 000	0.005
100 %		+30	680 500 006	2.7	0.000 000	0.004
100 %		+40	680 500 006	2.9	0.000 000	0.004
100 %		+50	680 500 007	3.8	0.000 001	0.006
Batt. Endpoint	3.400	+20	680 500 007	3.8	0.000 001	0.006



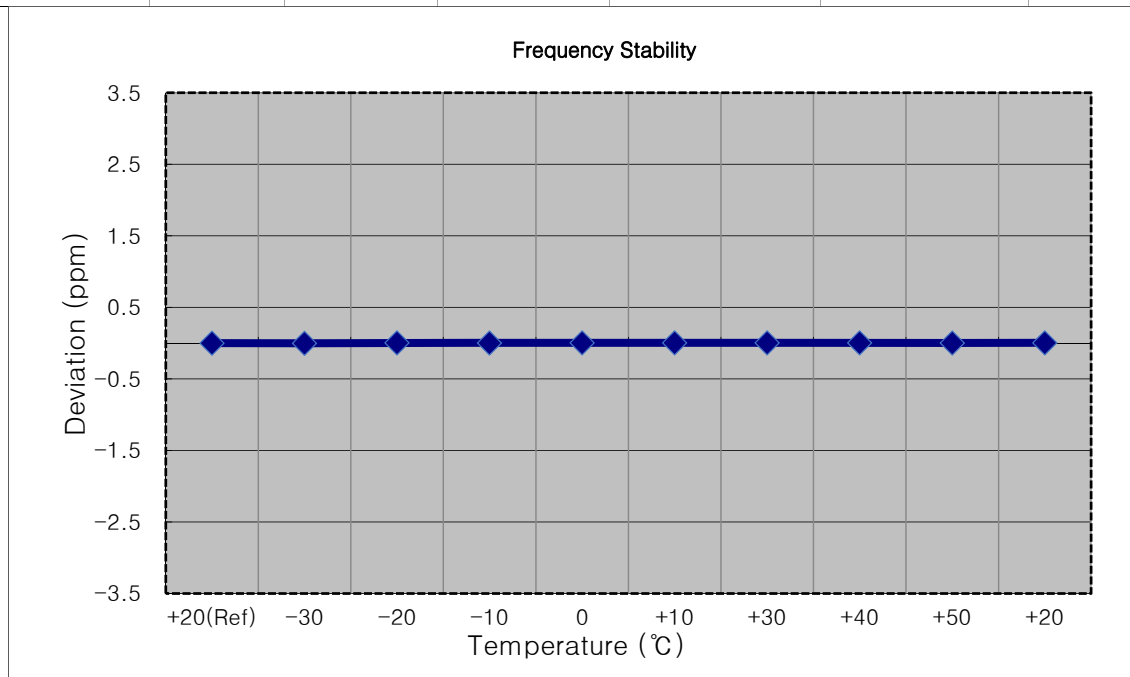
MODE: LTE B71
 OPERATING FREQUENCY: 680,500,000 Hz
 CHANNEL: 133297 (10 MHz)
 REFERENCE VOLTAGE: 3.900 VDC
 DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	680 500 002	0.0	0.000 000	0.000
100 %		-30	680 500 005	2.2	0.000 000	0.003
100 %		-20	680 500 004	1.9	0.000 000	0.003
100 %		-10	680 500 005	2.4	0.000 000	0.004
100 %		0	680 500 004	2.1	0.000 000	0.003
100 %		+10	680 500 004	2.1	0.000 000	0.003
100 %		+30	680 500 000	-1.9	0.000 000	-0.003
100 %		+40	680 500 005	2.7	0.000 000	0.004
100 %		+50	680 500 005	2.2	0.000 000	0.003
Batt. Endpoint	3.400	+20	680 500 001	-1.5	0.000 000	-0.002



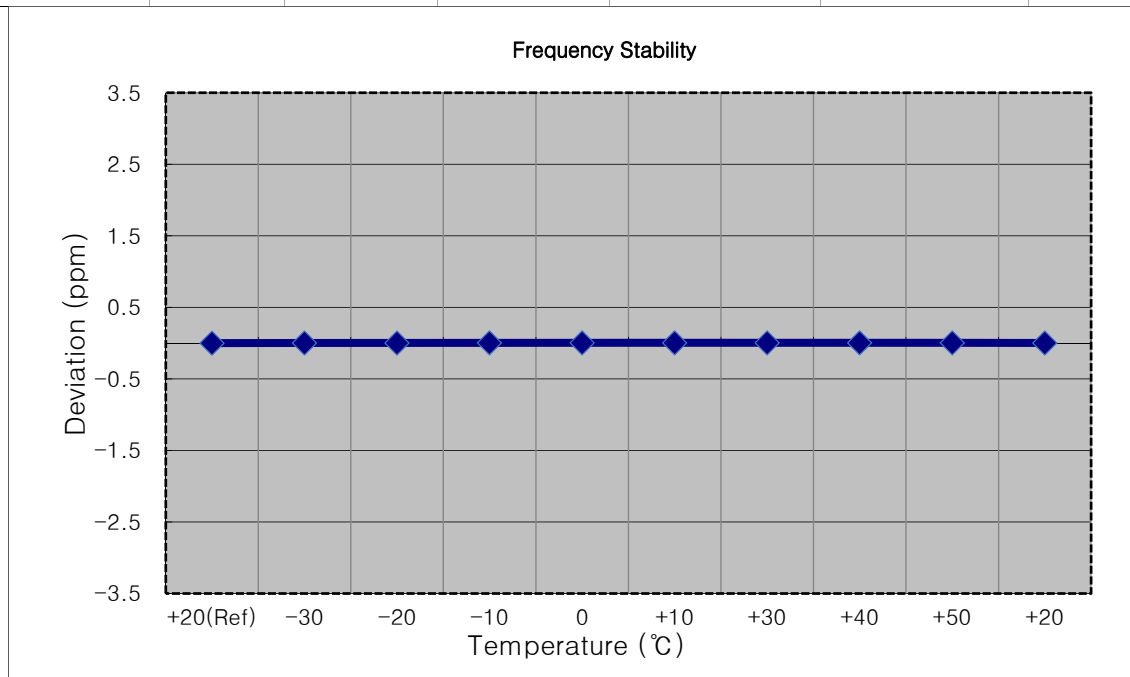
■ MODE: LTE B71
 ■ OPERATING FREQUENCY: 680,500,000 Hz
 ■ CHANNEL: 133297 (15 MHz)
 ■ REFERENCE VOLTAGE: 3.900 VDC
 ■ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	680 500 002	0.0	0.000 000	0.000
100 %		-30	680 500 000	-1.7	0.000 000	-0.002
100 %		-20	680 500 004	1.8	0.000 000	0.003
100 %		-10	680 500 003	1.4	0.000 000	0.002
100 %		0	680 500 004	1.8	0.000 000	0.003
100 %		+10	680 500 004	2.1	0.000 000	0.003
100 %		+30	680 500 004	2.4	0.000 000	0.004
100 %		+40	680 500 004	2.5	0.000 000	0.004
100 %		+50	680 500 003	1.1	0.000 000	0.002
Batt. Endpoint	3.400	+20	680 500 004	1.9	0.000 000	0.003



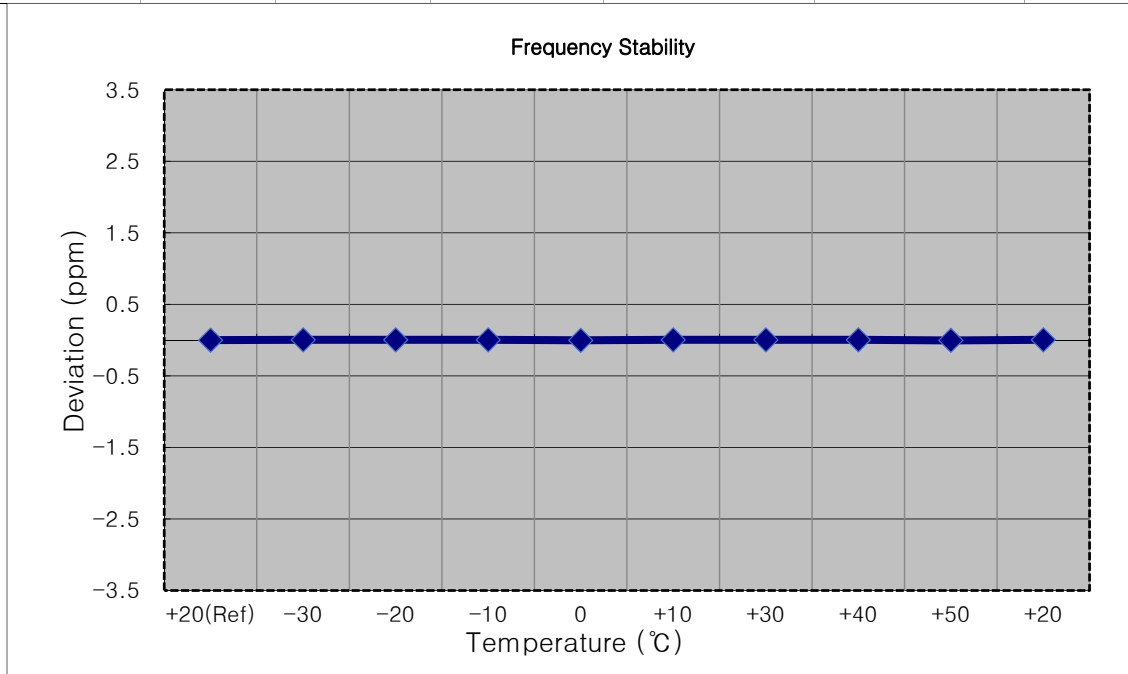
MODE: LTE B71
 OPERATING FREQUENCY: 680,500,000 Hz
 CHANNEL: 133297 (20 MHz)
 REFERENCE VOLTAGE: 3.900 VDC
 DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	680 500 002	0.0	0.000 000	0.000
100 %		-30	680 500 003	1.1	0.000 000	0.002
100 %		-20	680 500 003	0.9	0.000 000	0.001
100 %		-10	680 500 004	2.5	0.000 000	0.004
100 %		0	680 500 004	2.4	0.000 000	0.004
100 %		+10	680 500 005	2.6	0.000 000	0.004
100 %		+30	680 500 004	2.2	0.000 000	0.003
100 %		+40	680 500 005	2.6	0.000 000	0.004
100 %		+50	680 500 004	2.3	0.000 000	0.003
Batt. Endpoint	3.400	+20	680 500 003	1.1	0.000 000	0.002



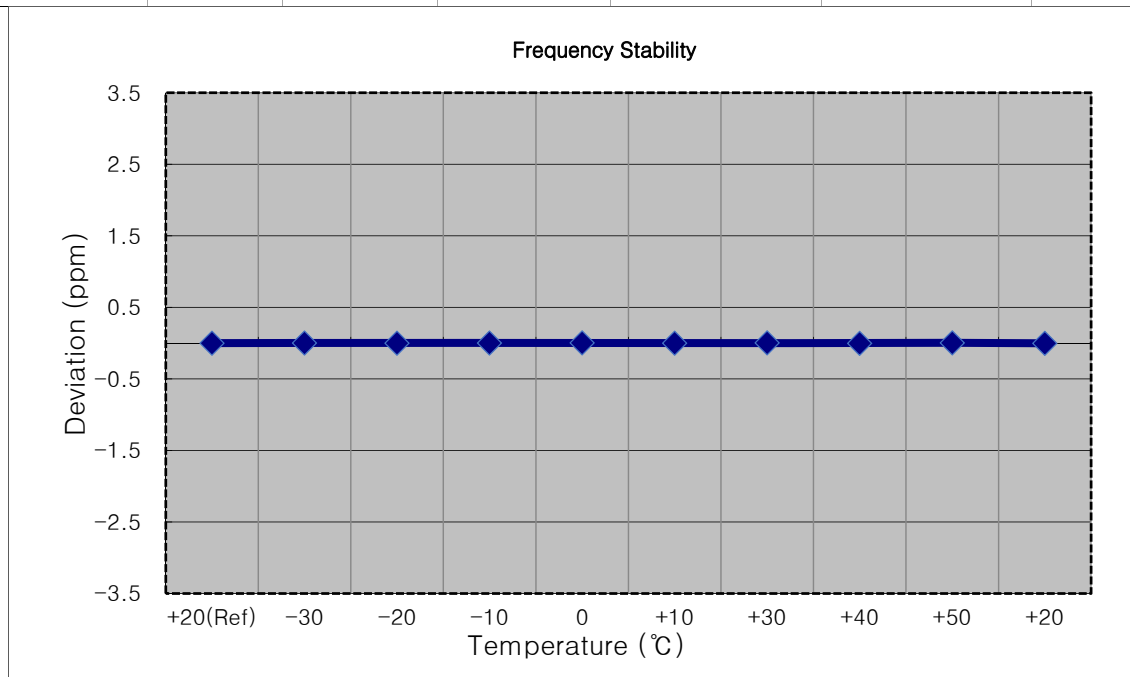
MODE: LTE B71
 OPERATING FREQUENCY: 695,500,000 Hz
 CHANNEL: 133447 (5 MHz)
 REFERENCE VOLTAGE: 3.900 VDC
 DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	695 500 002	0.0	0.000 000	0.000
100 %		-30	695 500 005	2.4	0.000 000	0.003
100 %		-20	695 500 005	2.4	0.000 000	0.003
100 %		-10	695 500 005	2.7	0.000 000	0.004
100 %		0	695 500 000	-2.4	0.000 000	-0.003
100 %		+10	695 500 005	2.5	0.000 000	0.004
100 %		+30	695 500 005	2.9	0.000 000	0.004
100 %		+40	695 500 005	2.9	0.000 000	0.004
100 %		+50	695 500 000	-2.5	0.000 000	-0.004
Batt. Endpoint	3.400	+20	695 500 005	2.8	0.000 000	0.004



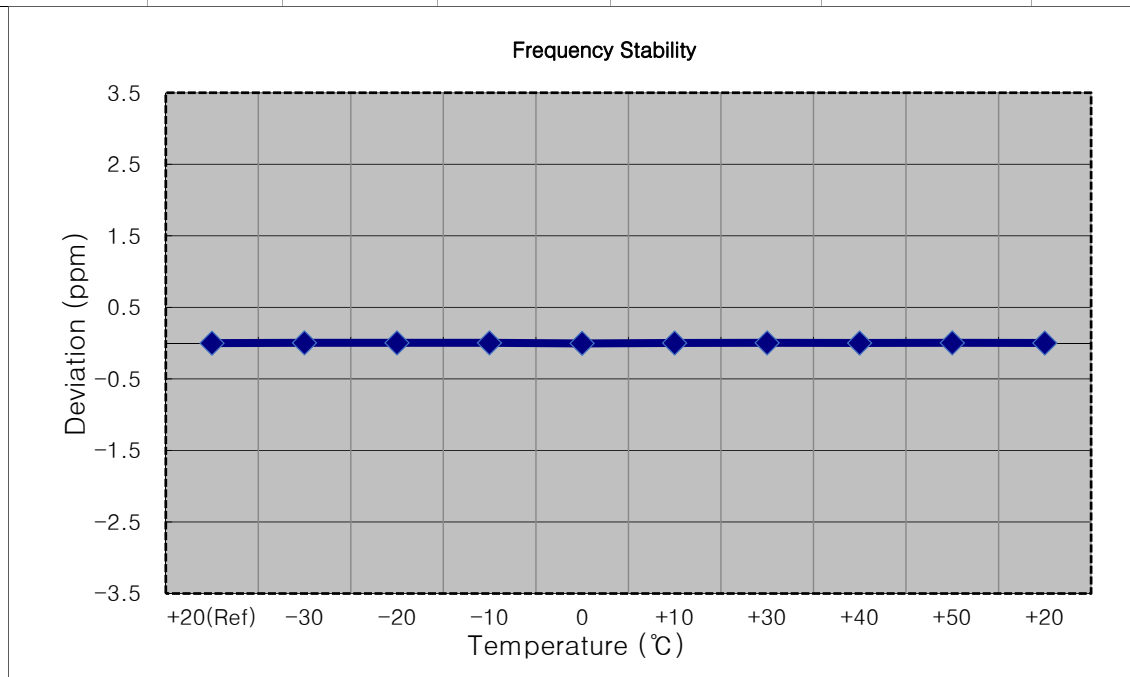
MODE:	<u>LTE B71</u>
OPERATING FREQUENCY:	<u>693,000,000 Hz</u>
CHANNEL:	<u>133422 (10 MHz)</u>
REFERENCE VOLTAGE:	<u>3.900 VDC</u>
DEVIATION LIMIT:	<u>Emission must remain in band</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	693 000 002	0.0	0.000 000	0.000
100 %		-30	693 000 004	1.5	0.000 000	0.002
100 %		-20	693 000 001	-0.9	0.000 000	-0.001
100 %		-10	693 000 004	1.3	0.000 000	0.002
100 %		0	693 000 004	1.8	0.000 000	0.003
100 %		+10	693 000 001	-1.2	0.000 000	-0.002
100 %		+30	693 000 005	2.4	0.000 000	0.003
100 %		+40	693 000 001	-1.5	0.000 000	-0.002
100 %		+50	693 000 005	2.2	0.000 000	0.003
Batt. Endpoint	3.400	+20	693 000 000	-1.9	0.000 000	-0.003



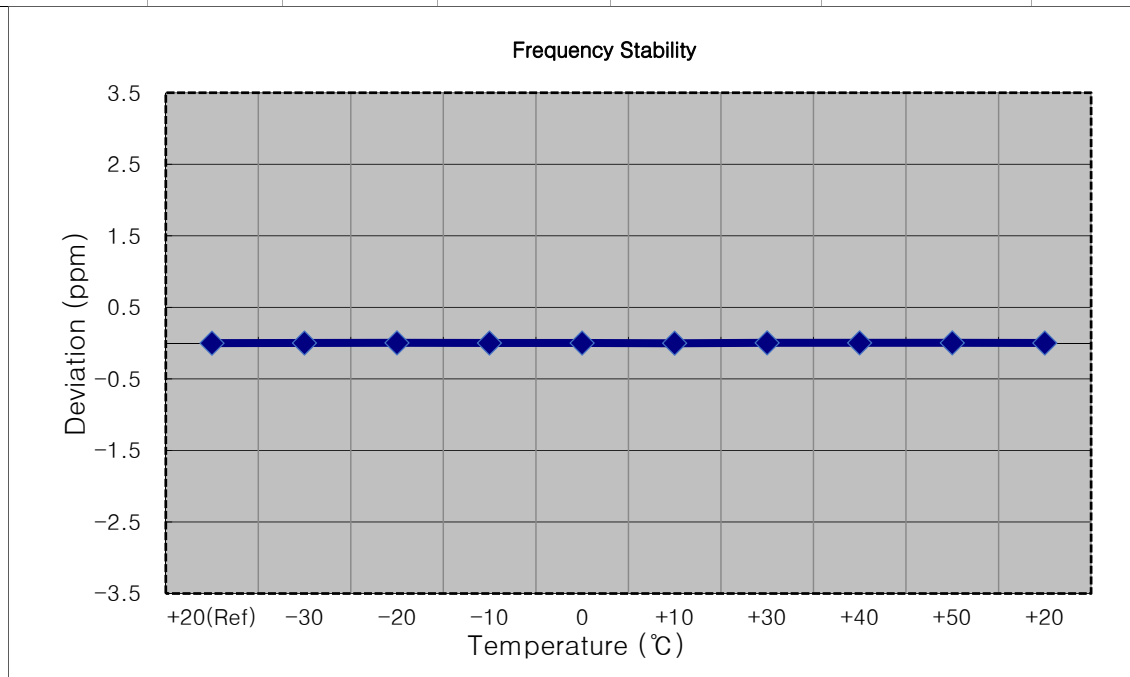
MODE:	<u>LTE B71</u>
OPERATING FREQUENCY:	<u>690,500,000 Hz</u>
CHANNEL:	<u>133397 (15 MHz)</u>
REFERENCE VOLTAGE:	<u>3.900 VDC</u>
DEVIATION LIMIT:	<u>Emission must remain in band</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	690 500 002	0.0	0.000 000	0.000
100 %		-30	690 500 004	2.1	0.000 000	0.003
100 %		-20	690 500 004	2.1	0.000 000	0.003
100 %		-10	690 500 004	2.5	0.000 000	0.004
100 %		0	690 499 999	-2.3	0.000 000	-0.003
100 %		+10	690 500 003	1.7	0.000 000	0.002
100 %		+30	690 500 004	2.0	0.000 000	0.003
100 %		+40	690 500 003	1.2	0.000 000	0.002
100 %		+50	690 500 005	3.2	0.000 000	0.005
Batt. Endpoint	3.400	+20	690 500 003	1.0	0.000 000	0.001



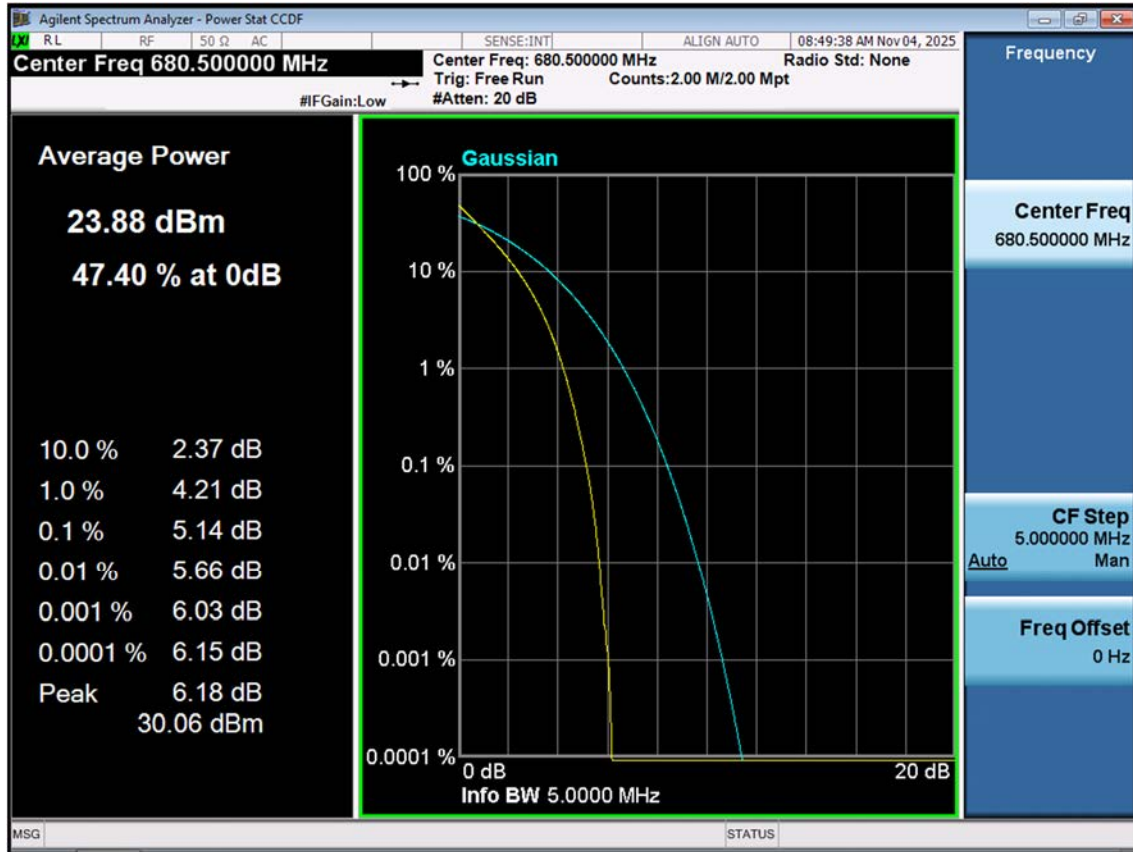
MODE:	<u>LTE B71</u>
OPERATING FREQUENCY:	<u>688,000,000 Hz</u>
CHANNEL:	<u>133372 (20 MHz)</u>
REFERENCE VOLTAGE:	<u>3.900 VDC</u>
DEVIATION LIMIT:	<u>Emission must remain in band</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.900	+20(Ref)	687 999 999	0.0	0.000 000	0.000
100 %		-30	688 000 000	1.2	0.000 000	0.002
100 %		-20	688 000 001	2.2	0.000 000	0.003
100 %		-10	688 000 000	1.2	0.000 000	0.002
100 %		0	688 000 000	1.3	0.000 000	0.002
100 %		+10	687 999 998	-1.3	0.000 000	-0.002
100 %		+30	688 000 002	2.7	0.000 000	0.004
100 %		+40	688 000 002	2.9	0.000 000	0.004
100 %		+50	688 000 001	1.8	0.000 000	0.003
Batt. Endpoint	3.400	+20	688 000 000	1.1	0.000 000	0.002

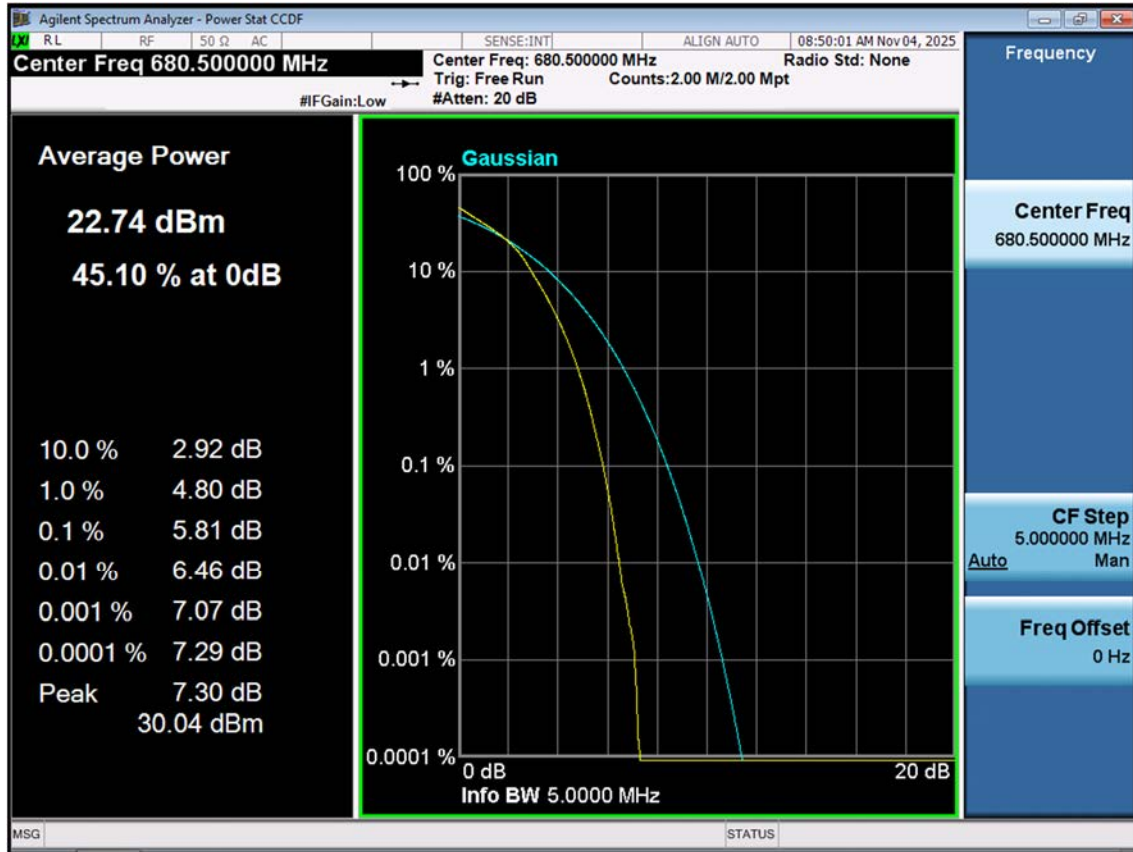


9. TEST PLOTS

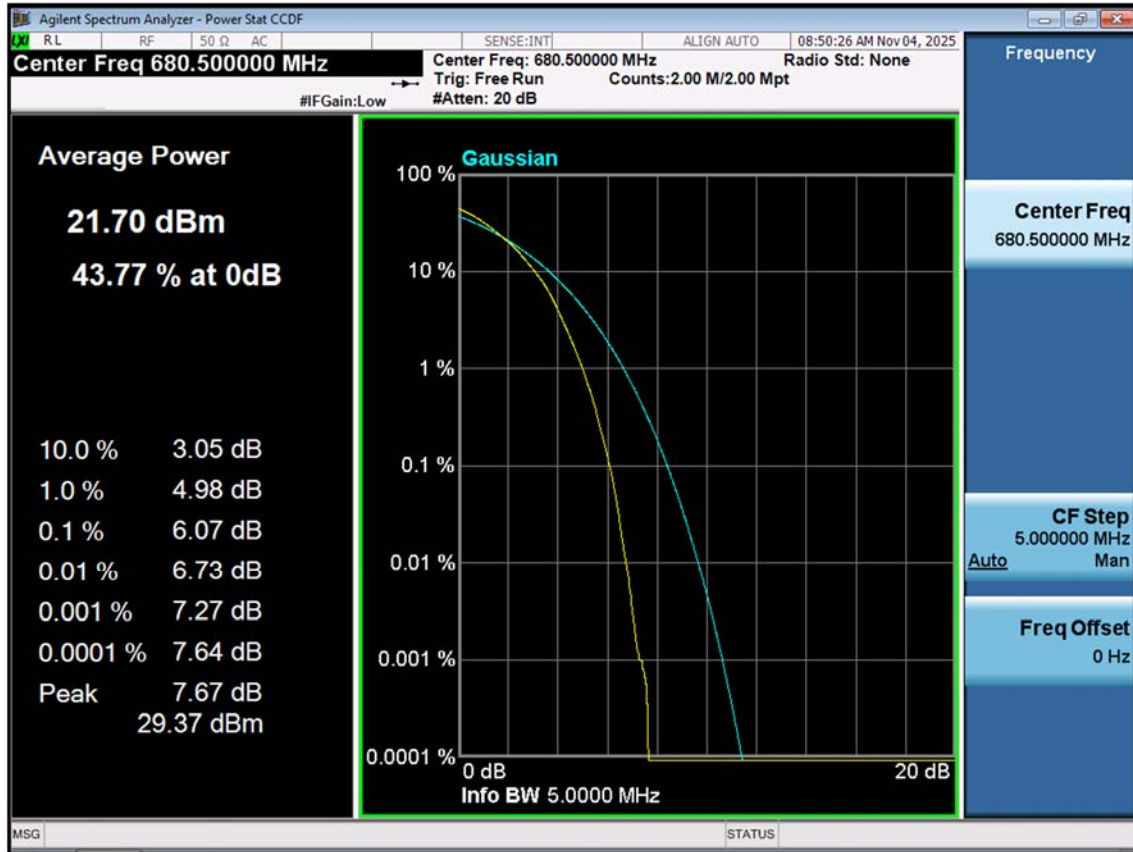
LTE B71_5 M_PAR_Mid_QPSK_FullRB



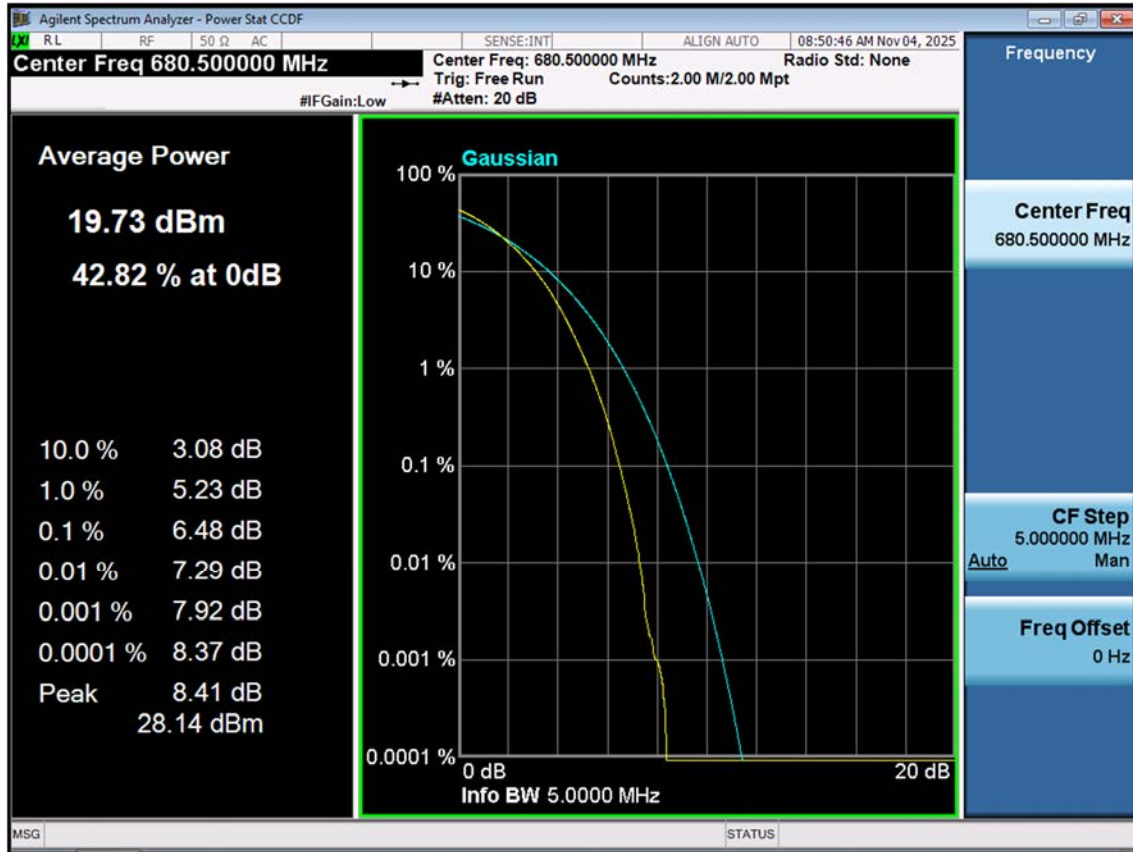
LTE B71_5 M_PAR_Mid_16QAM_FullRB



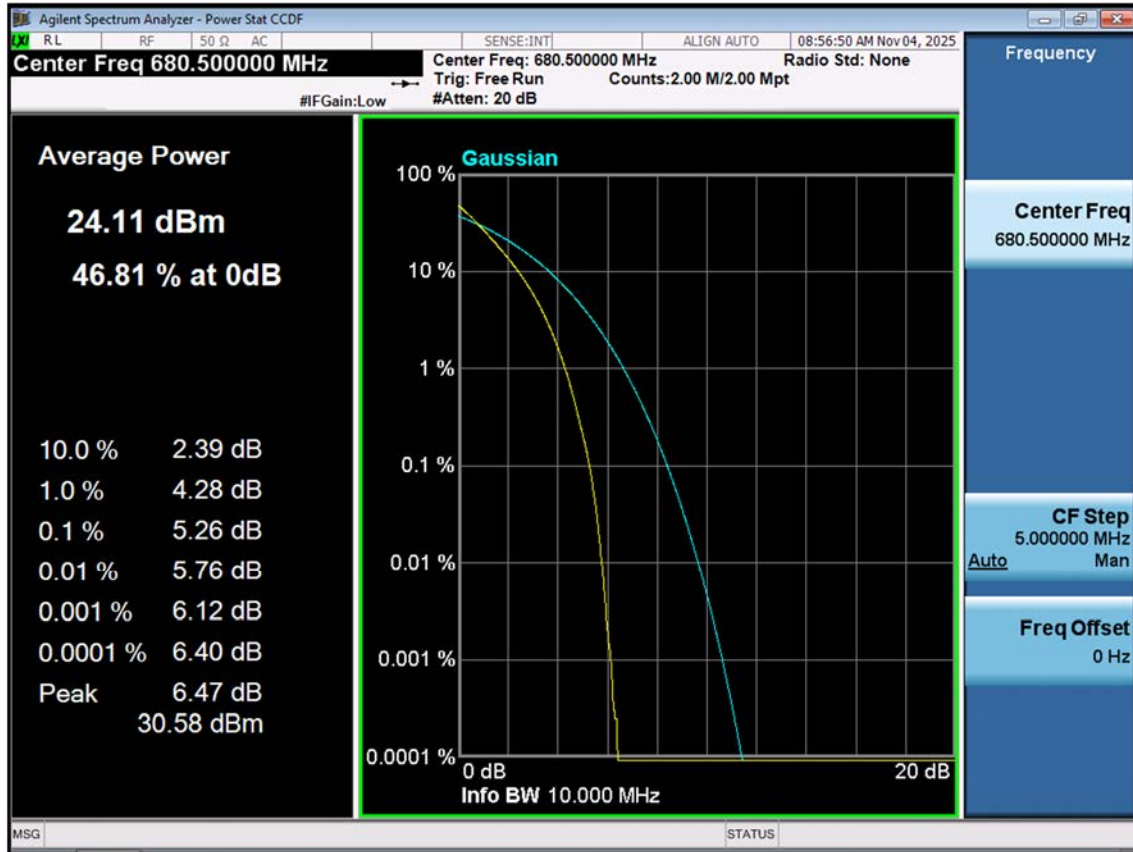
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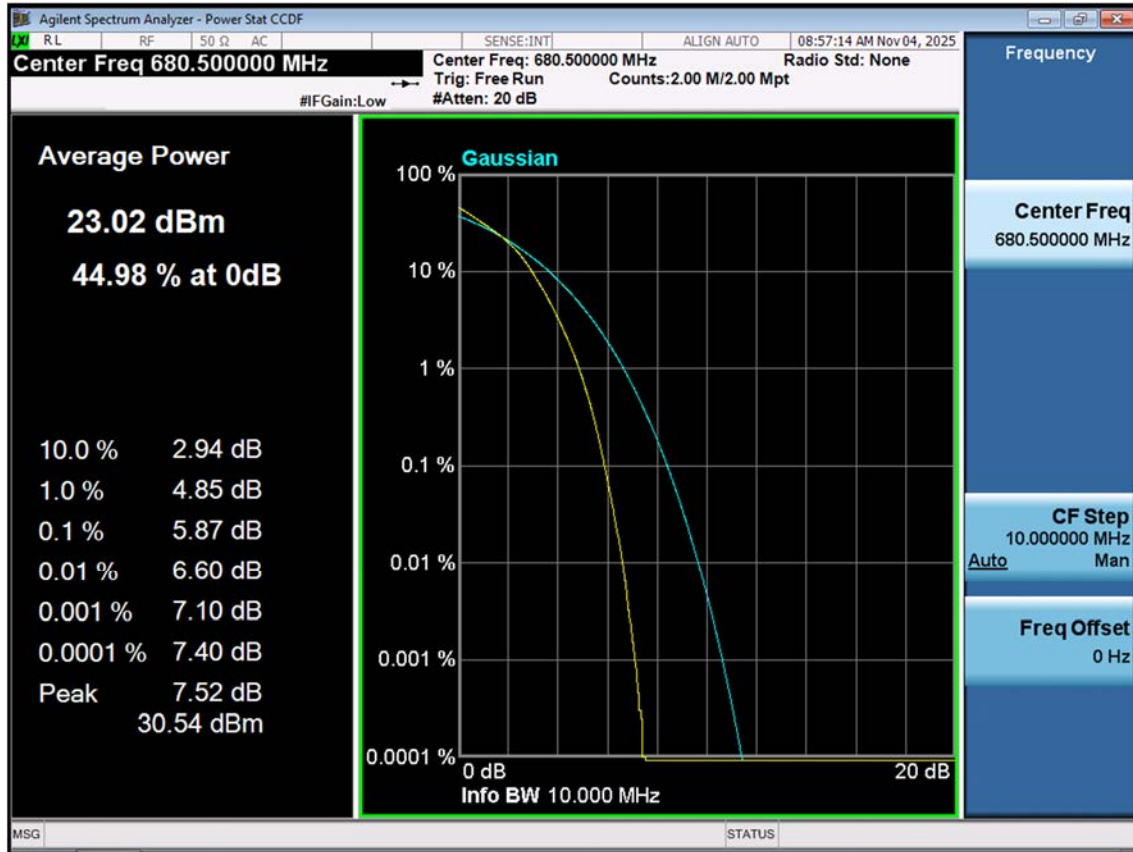
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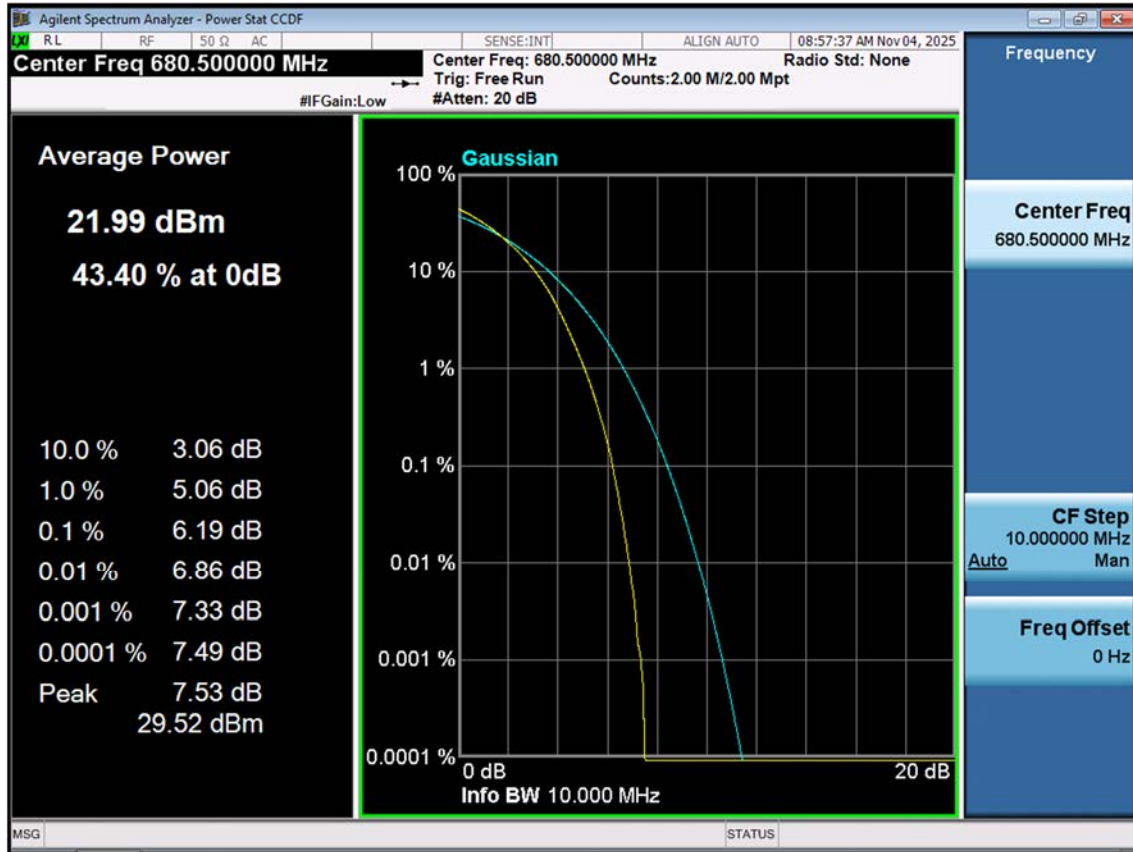
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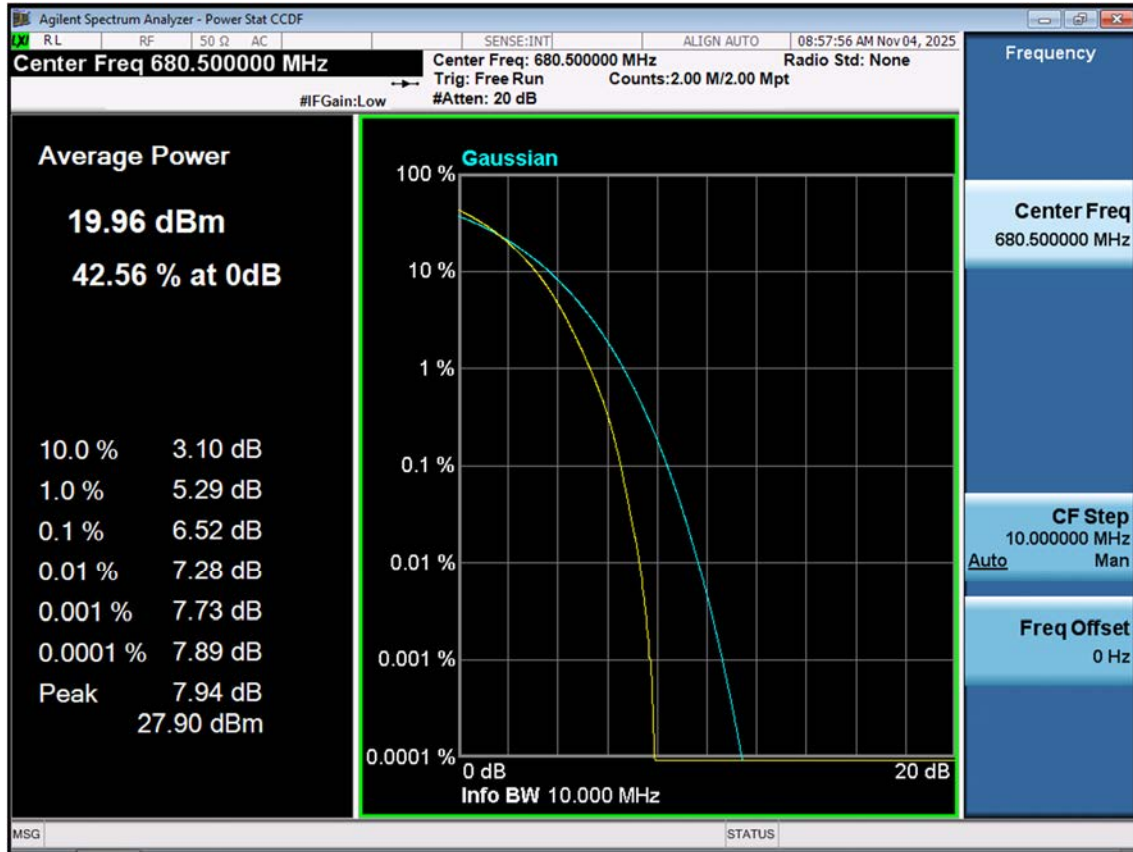
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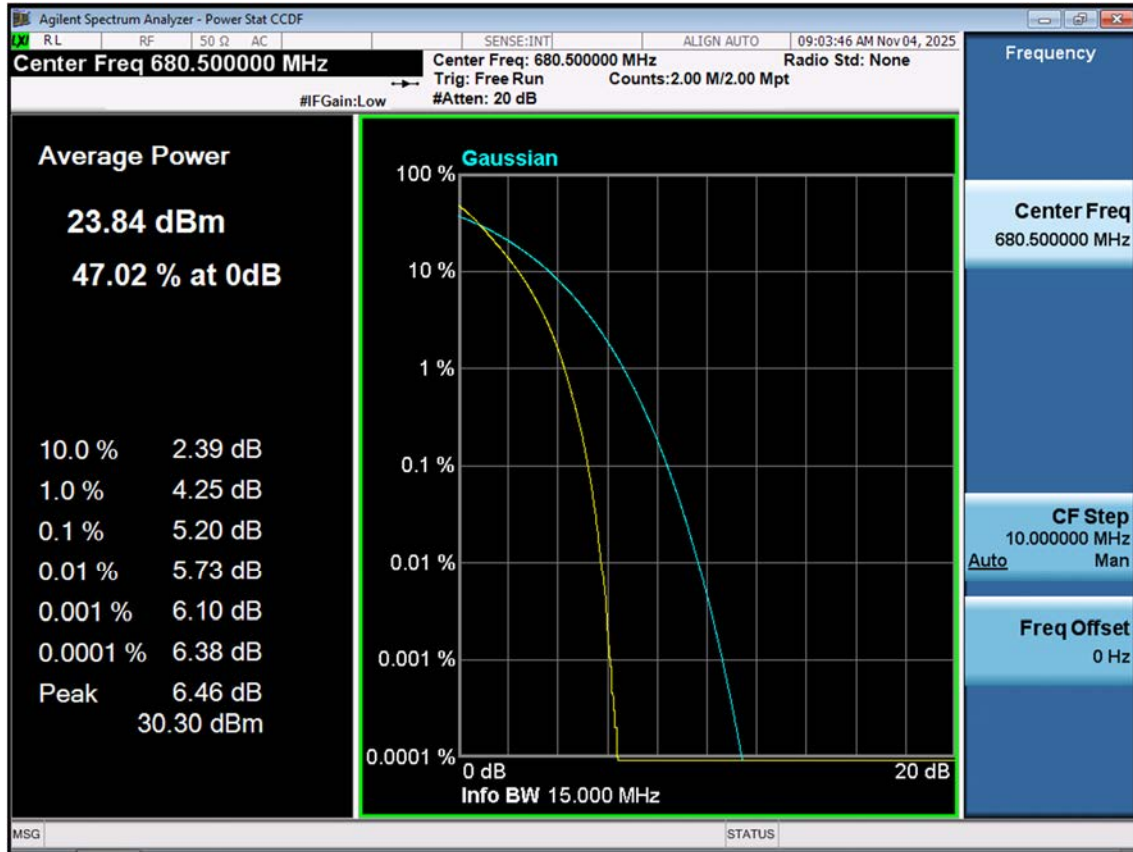
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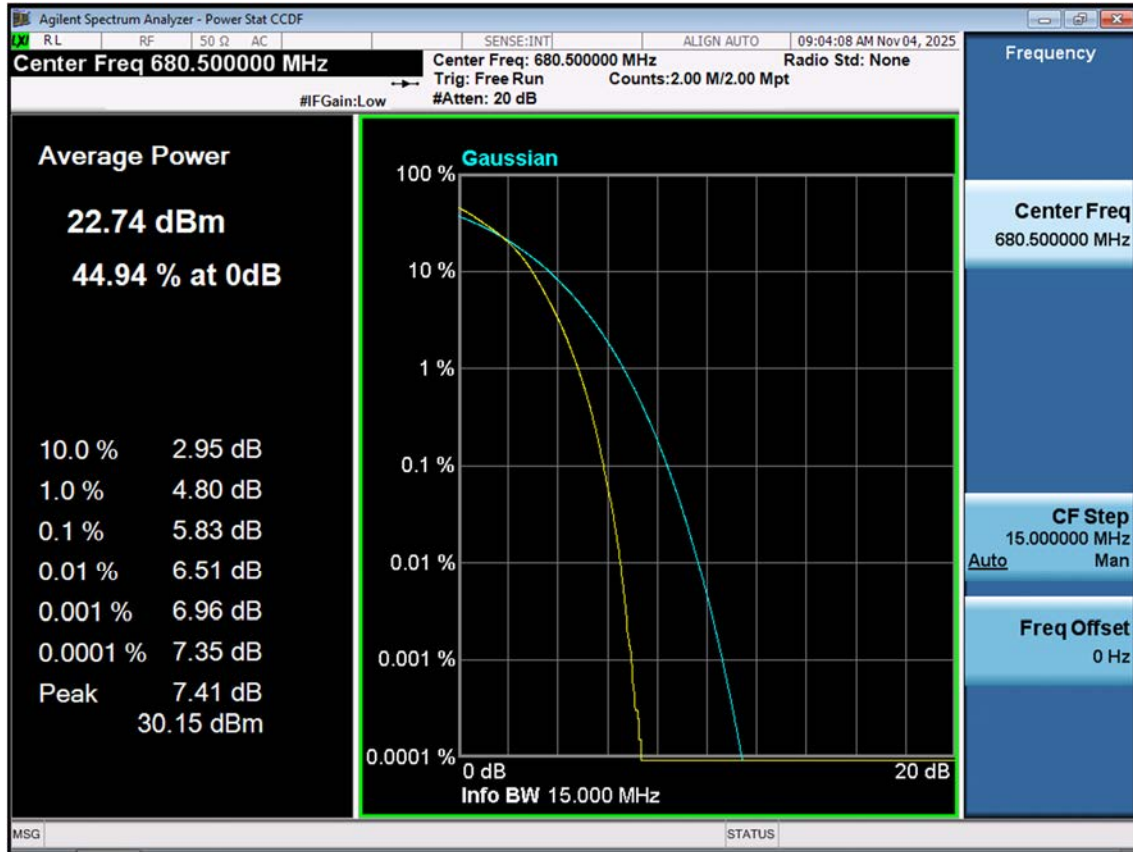
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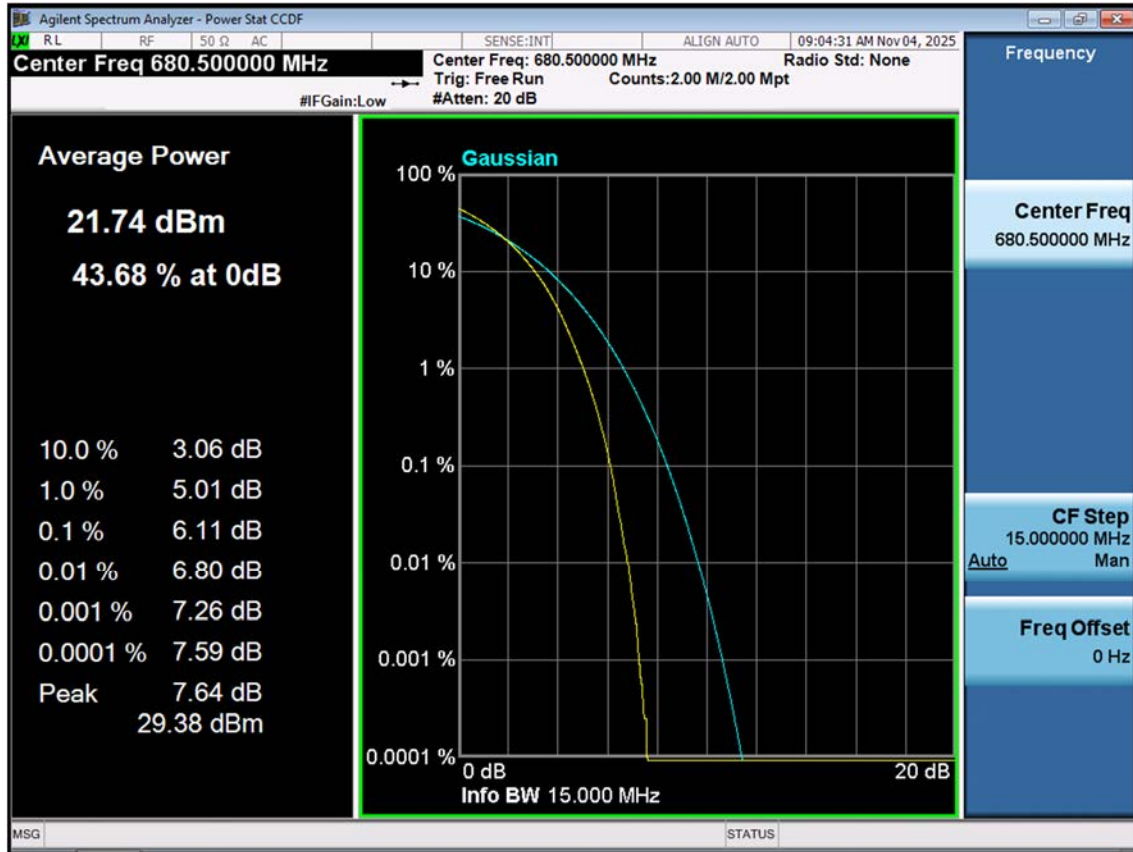
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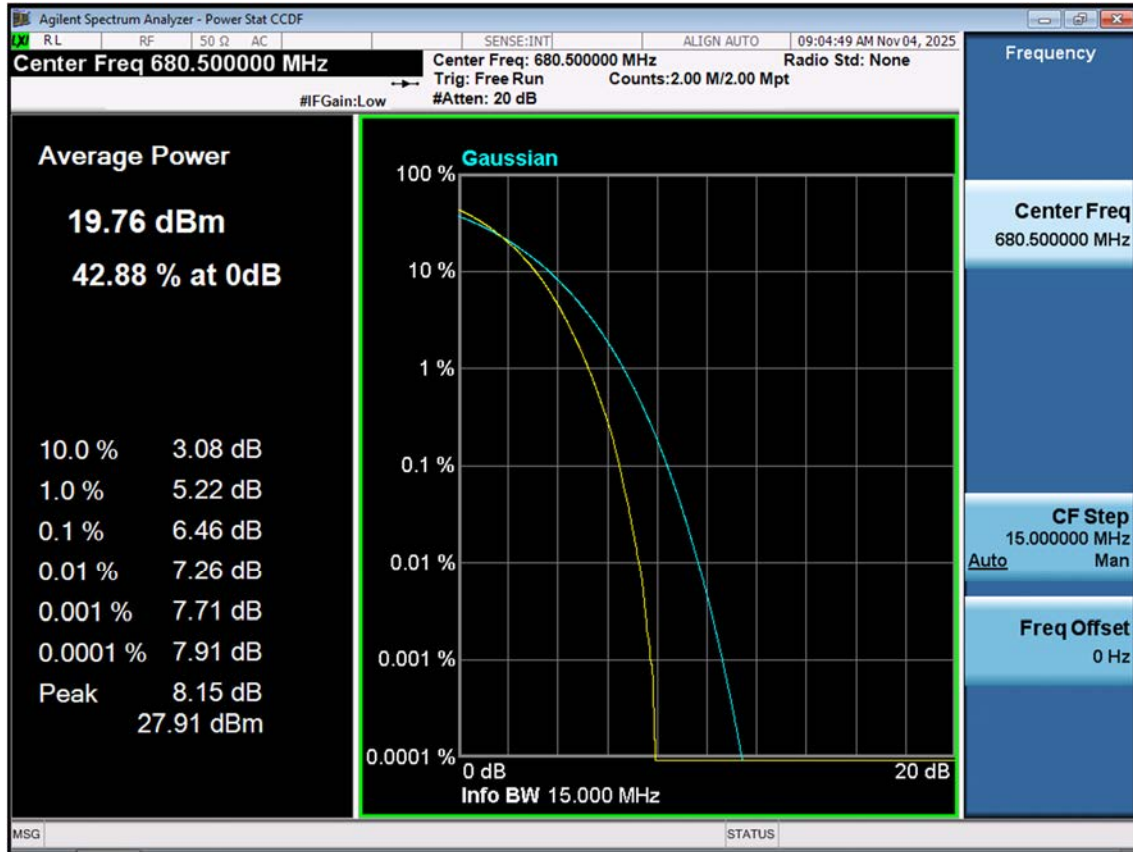
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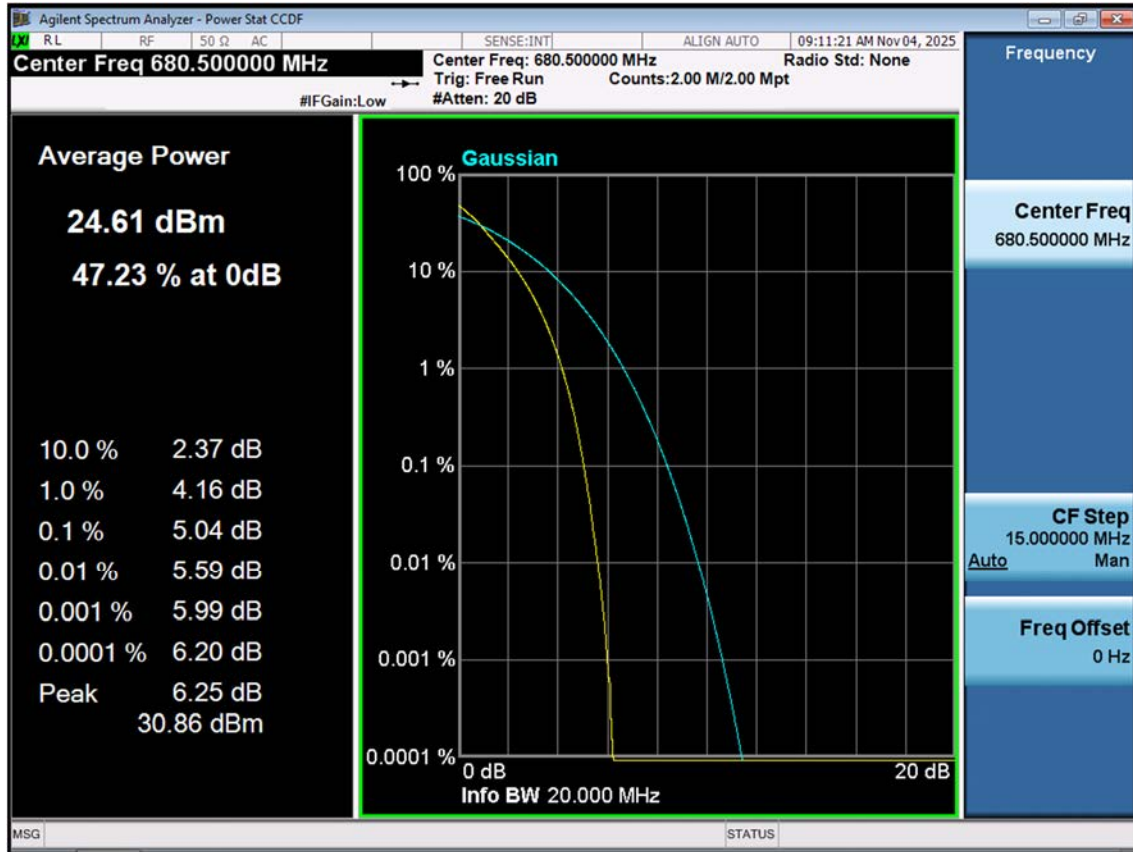
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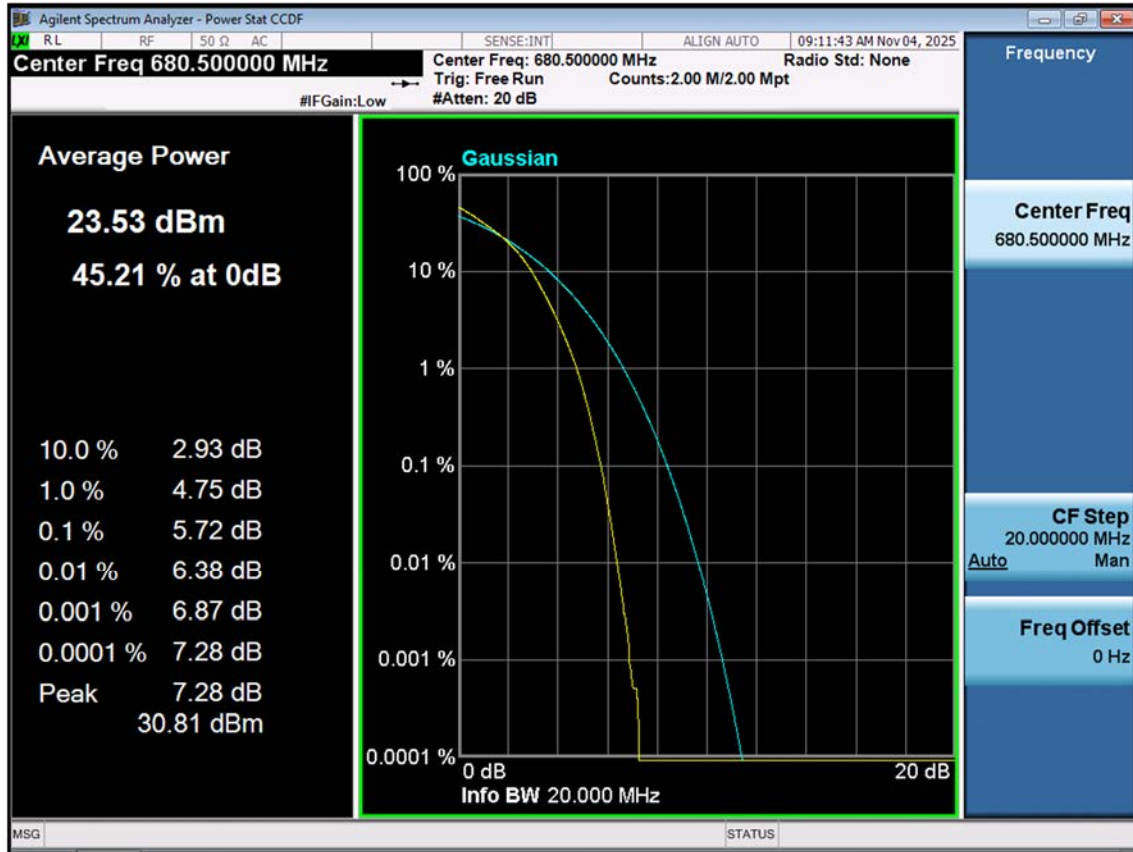
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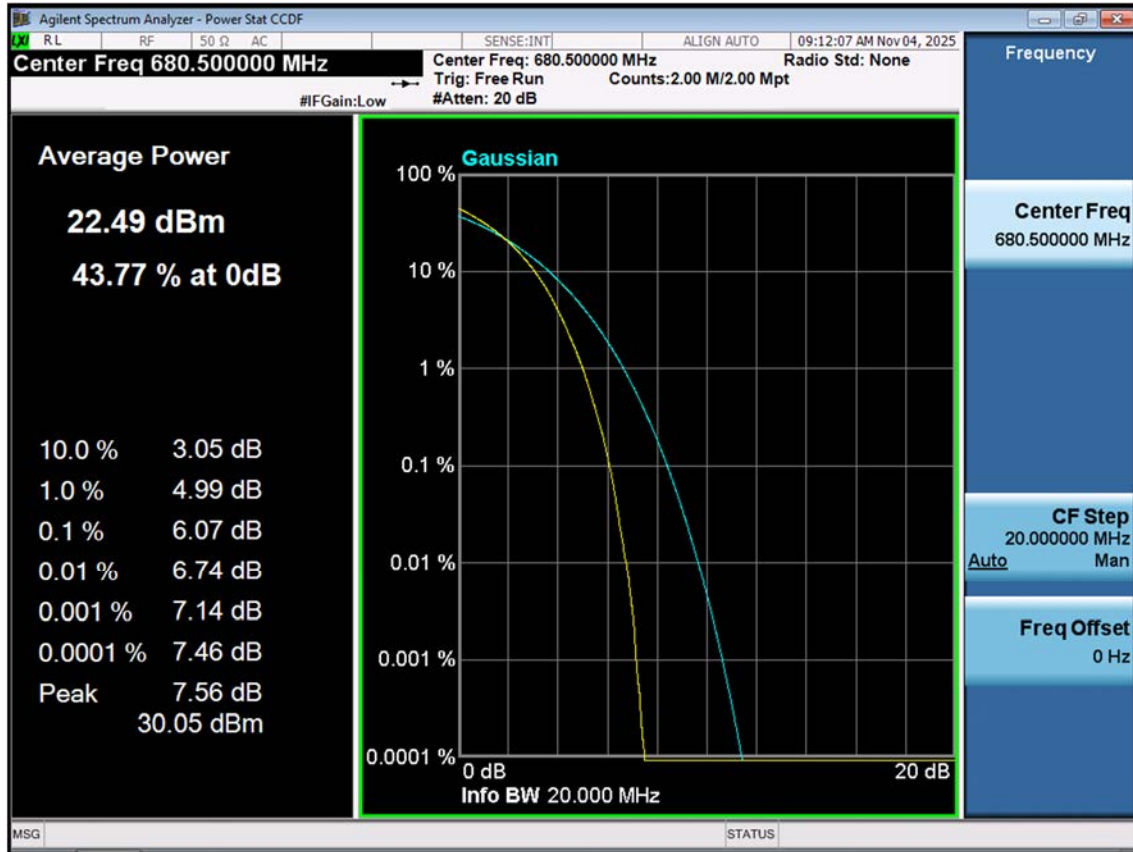
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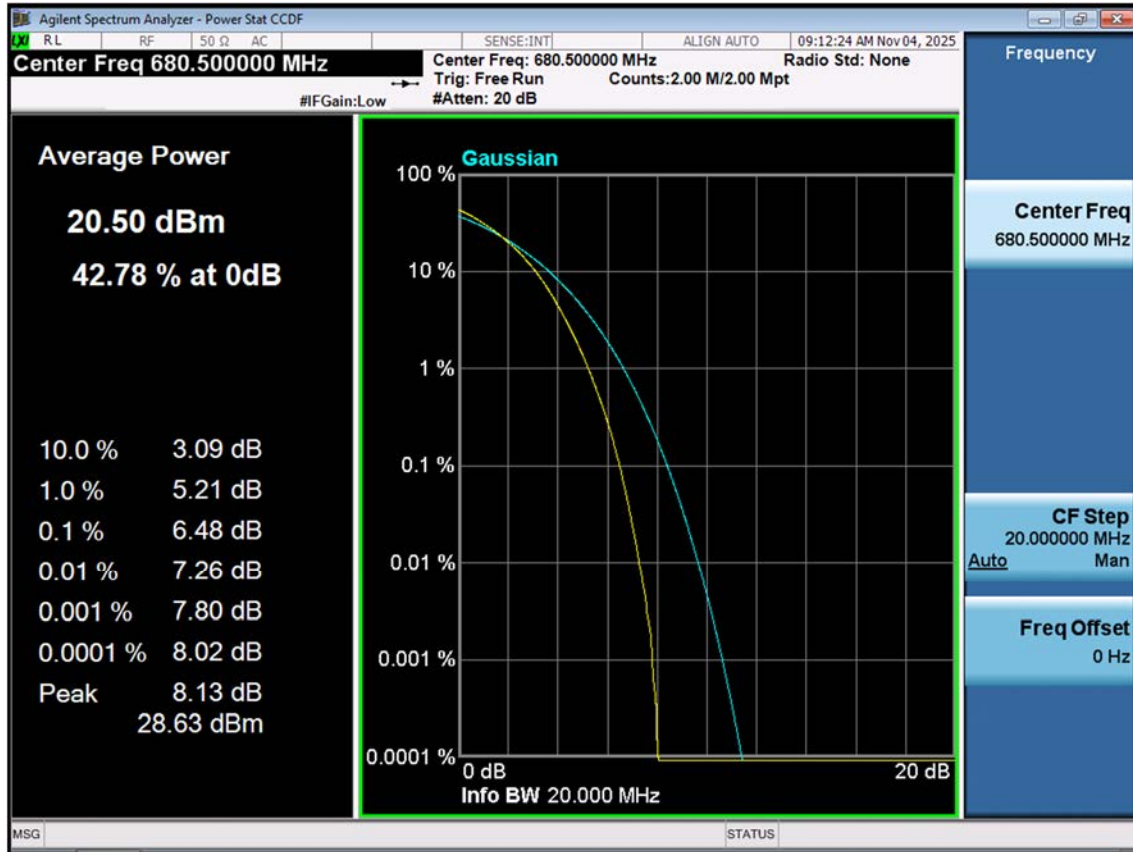
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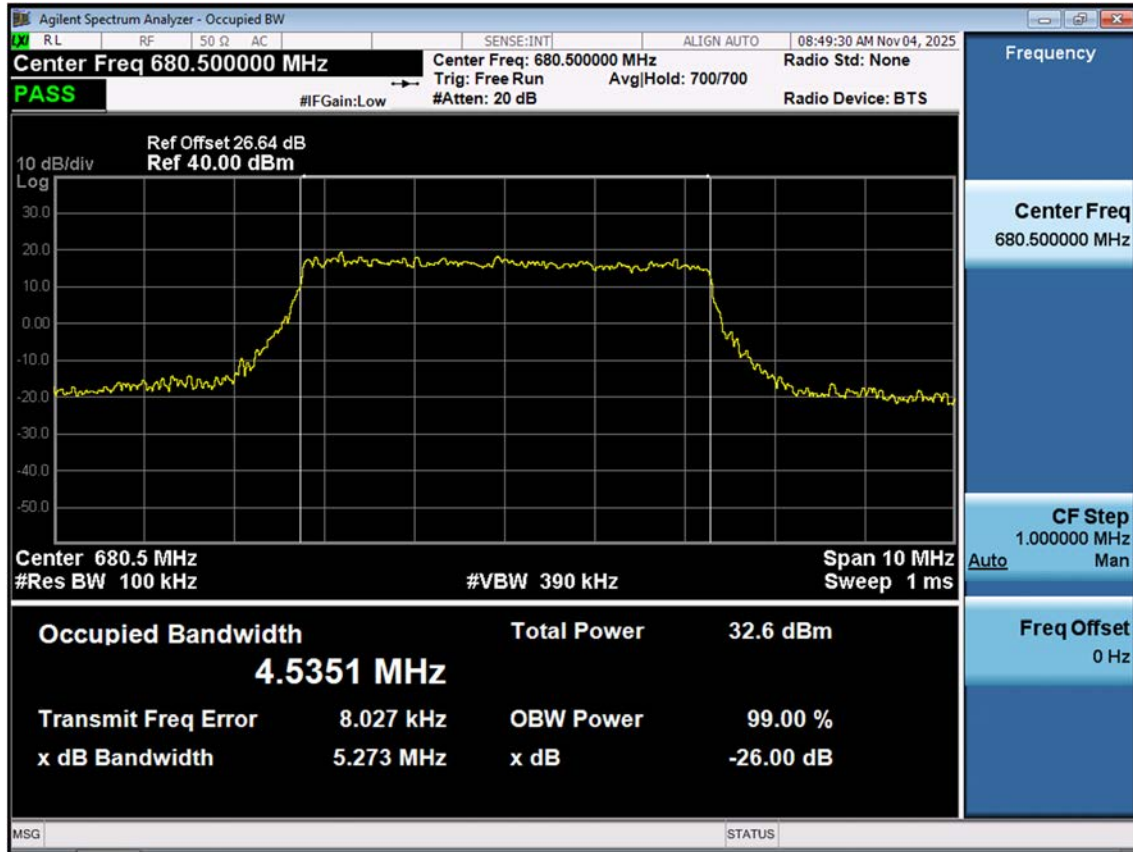
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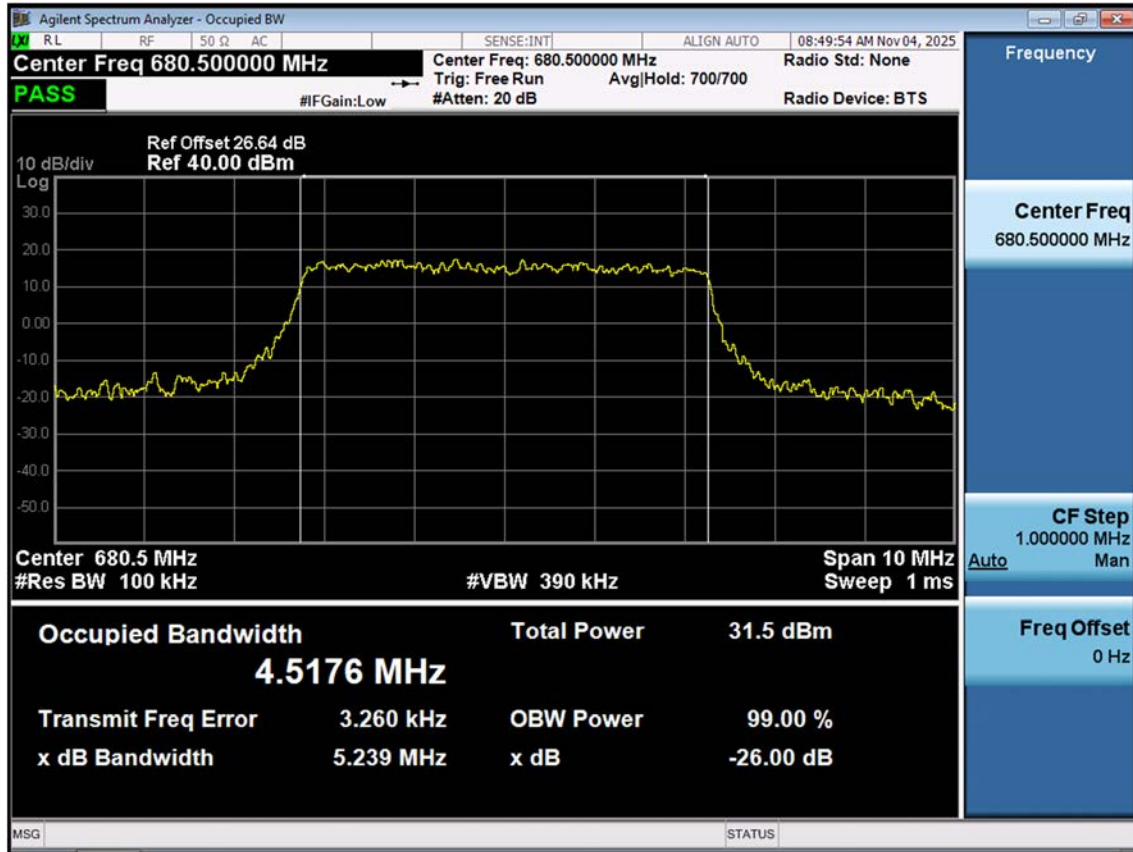
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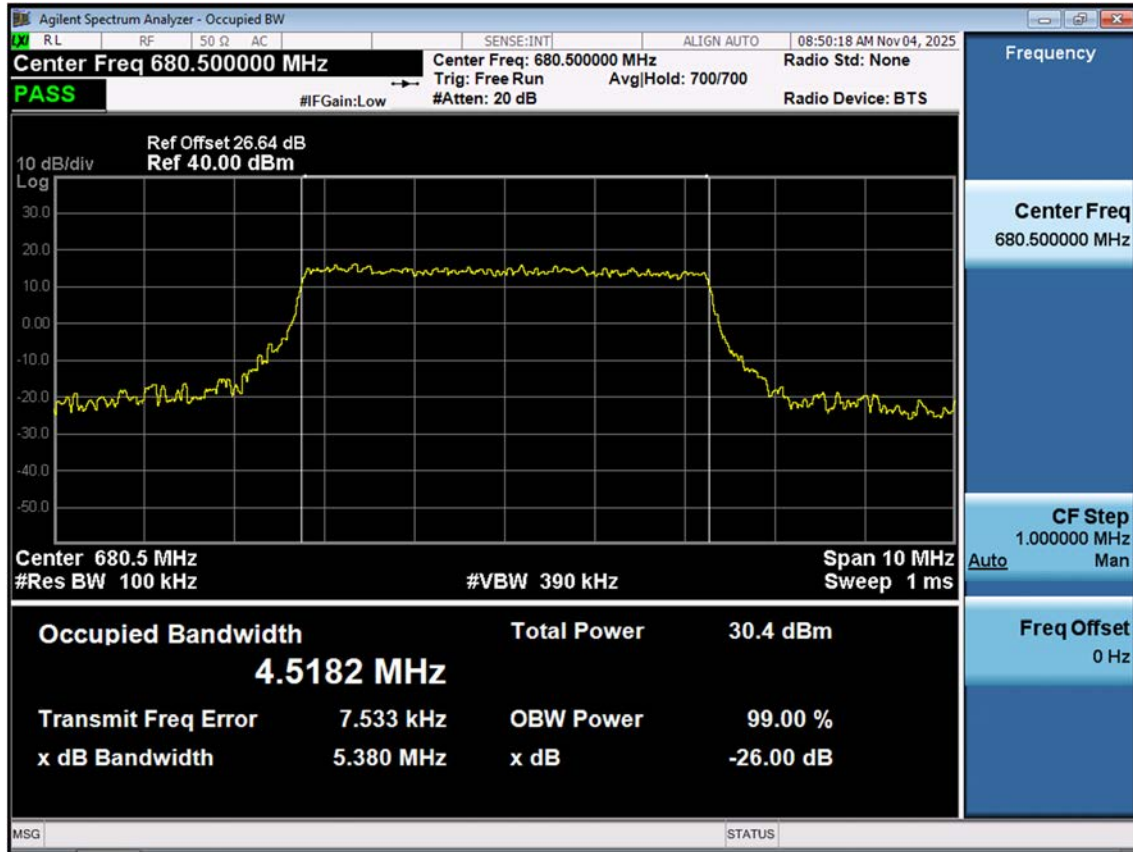
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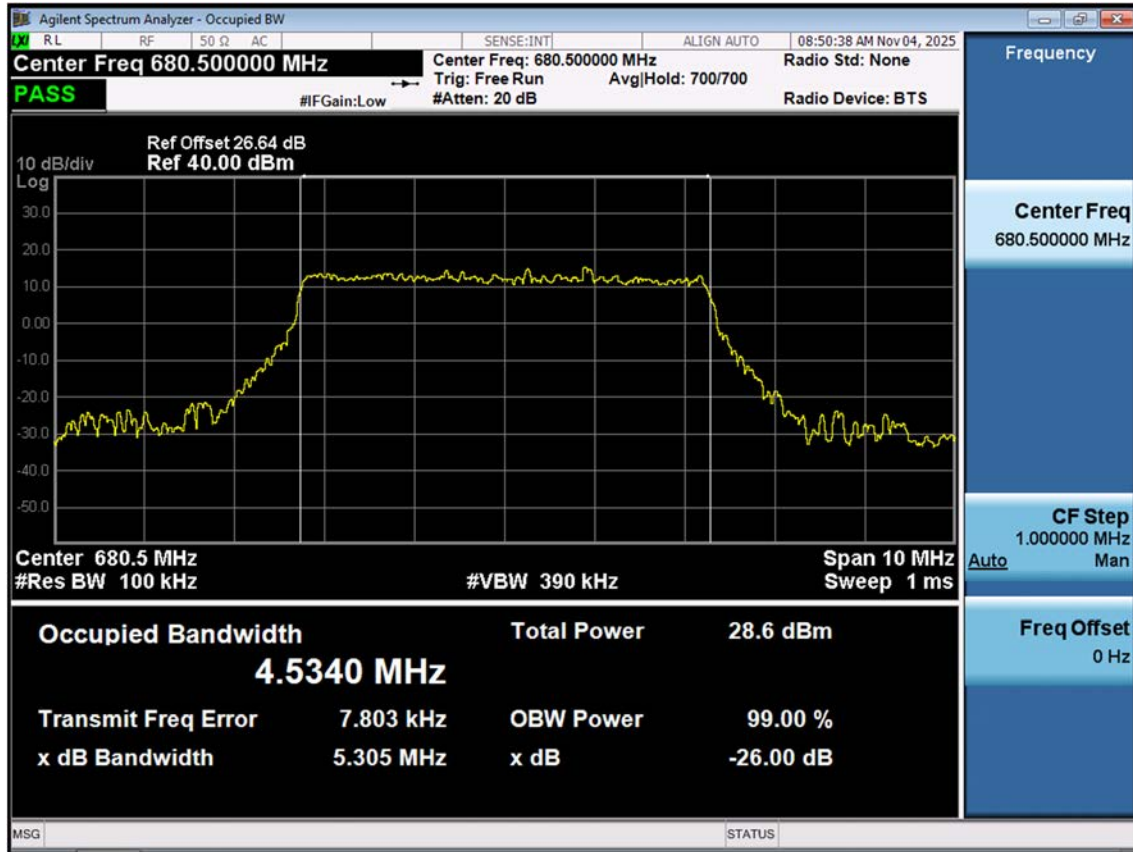
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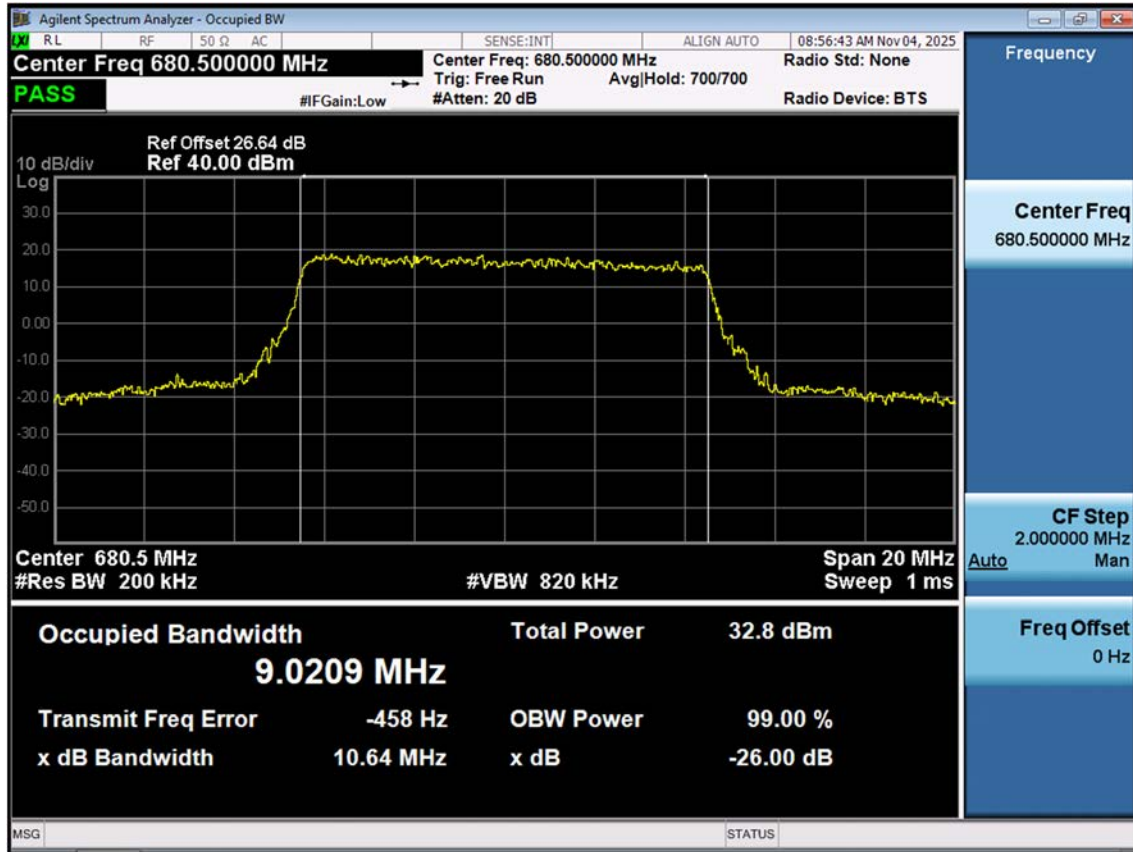
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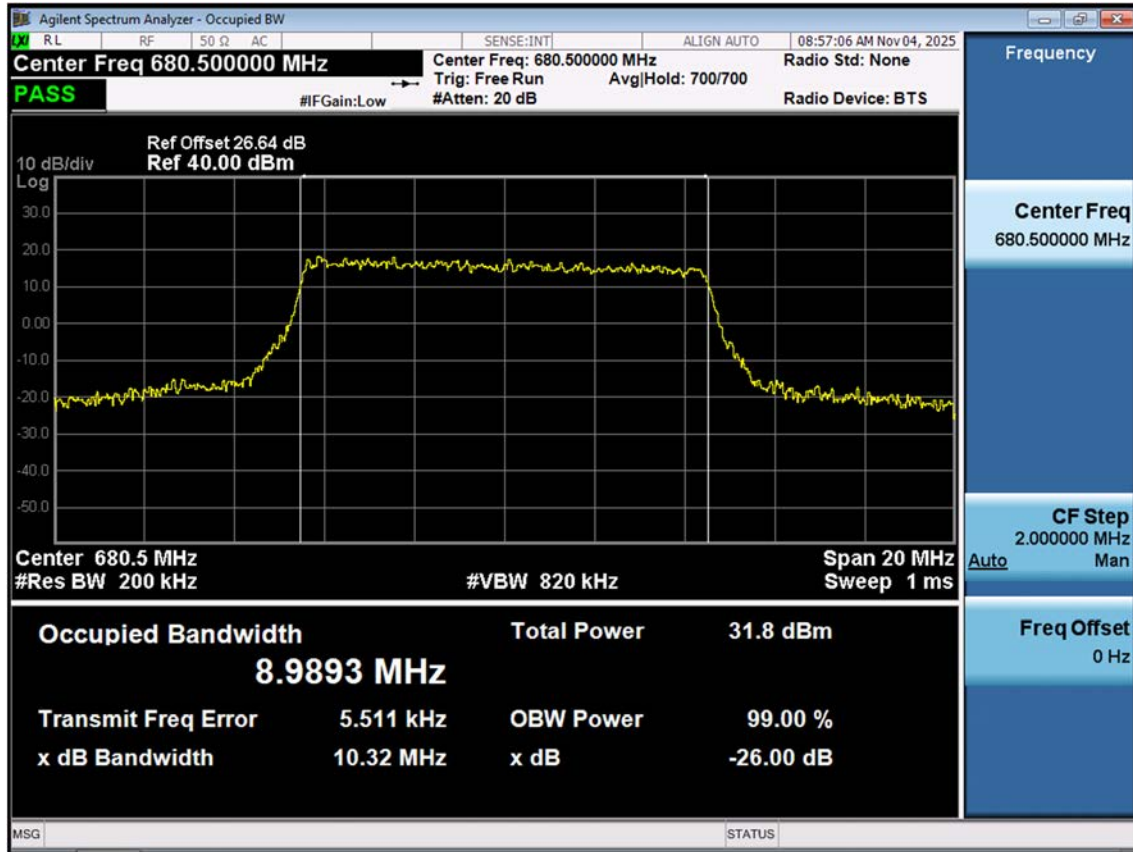
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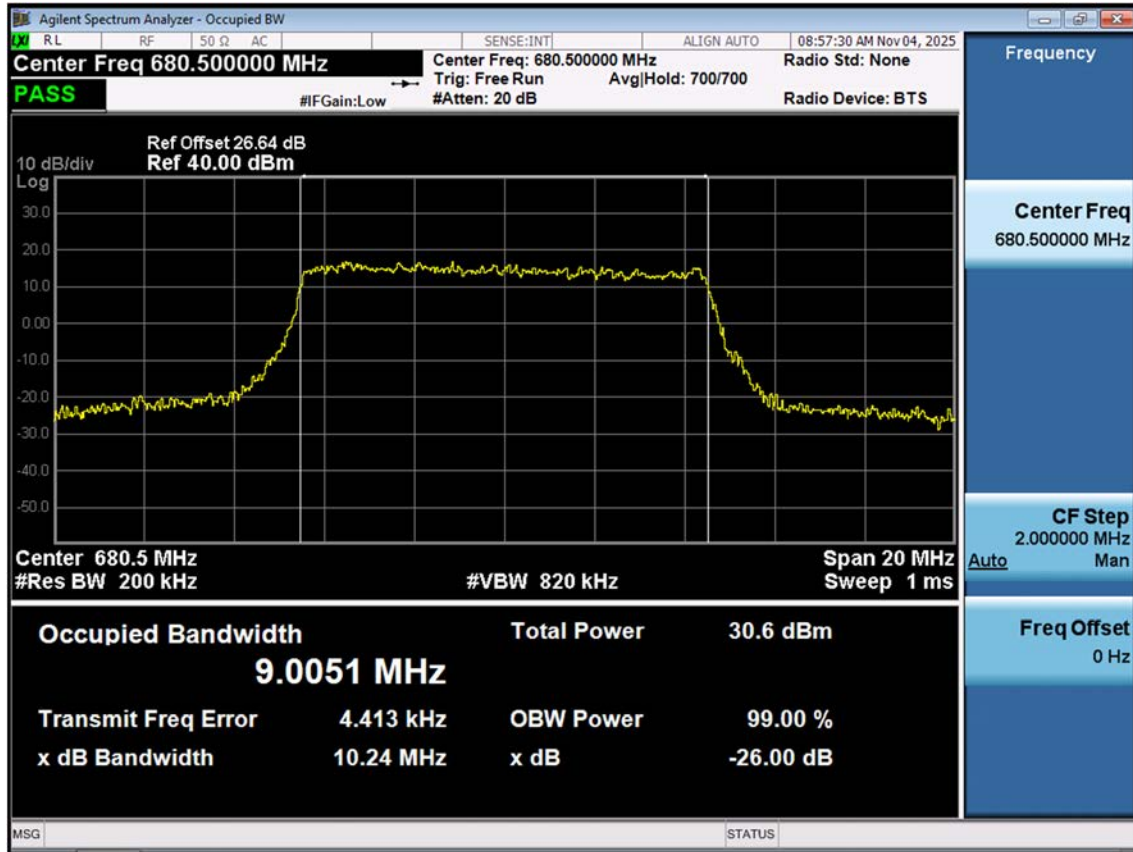
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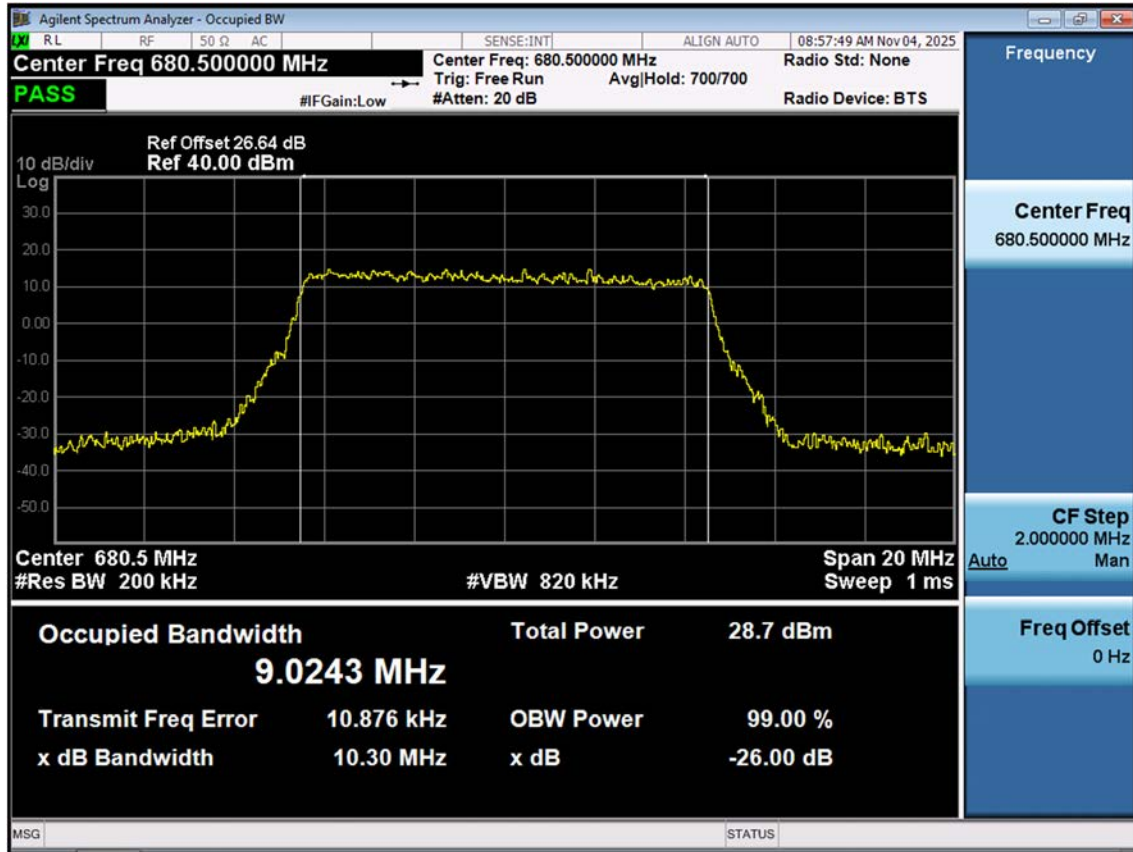
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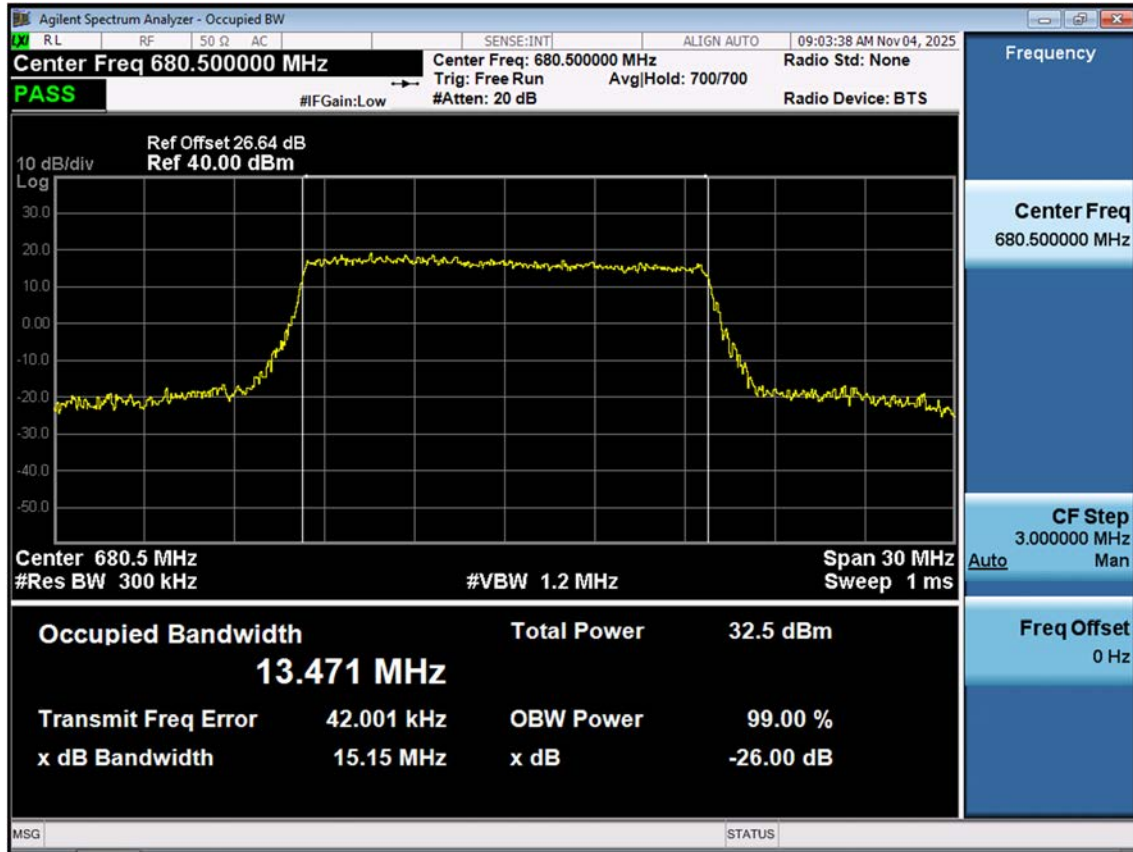
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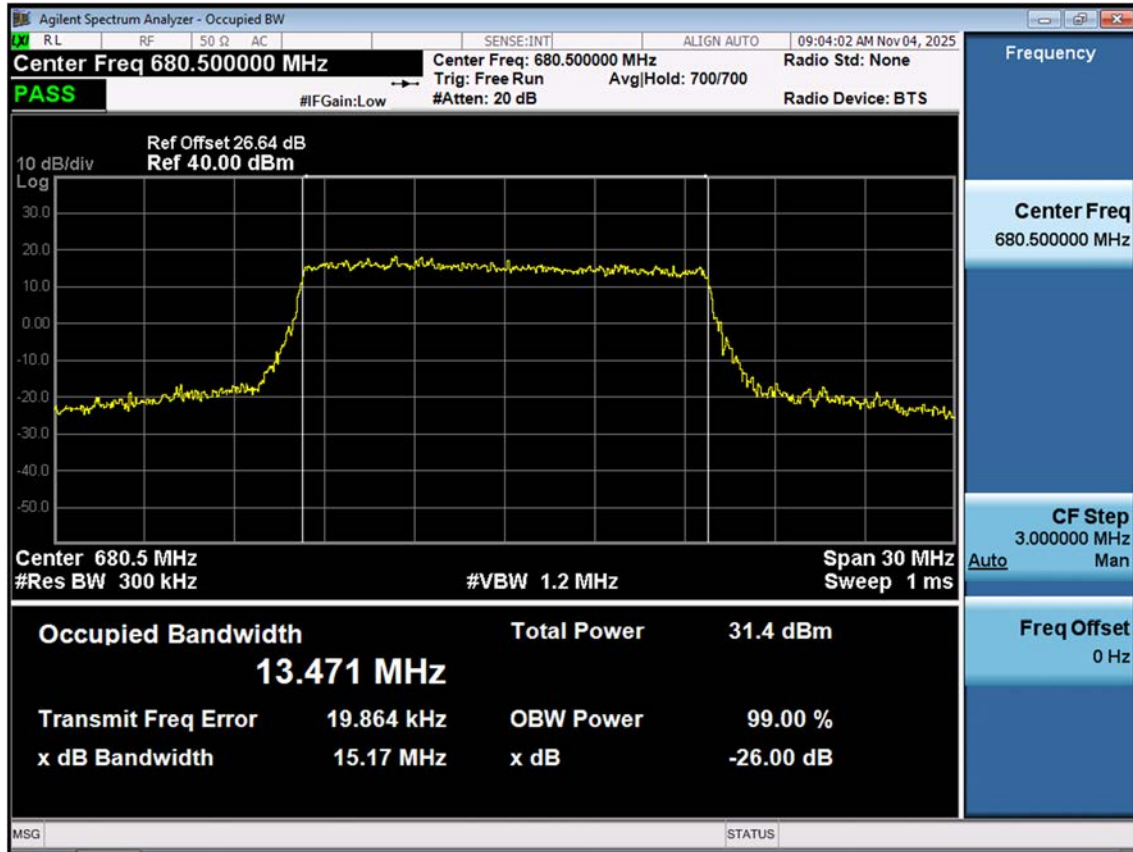
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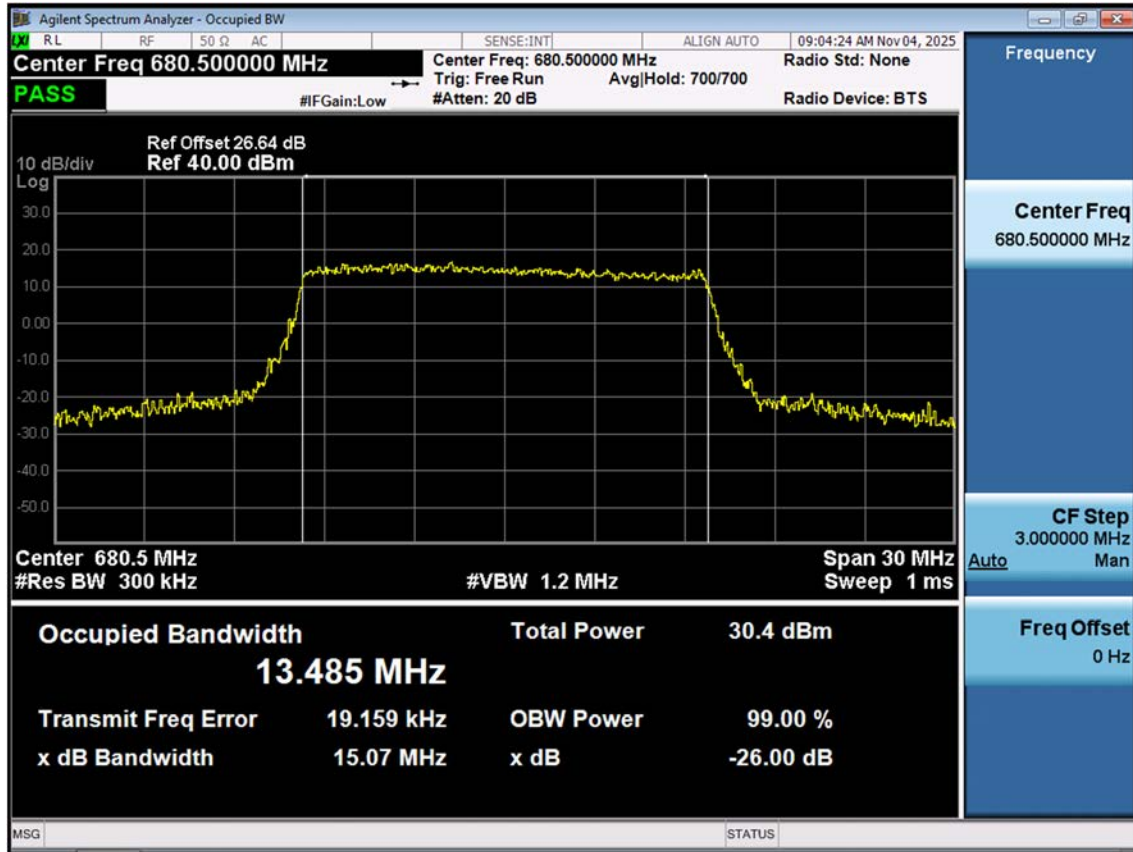
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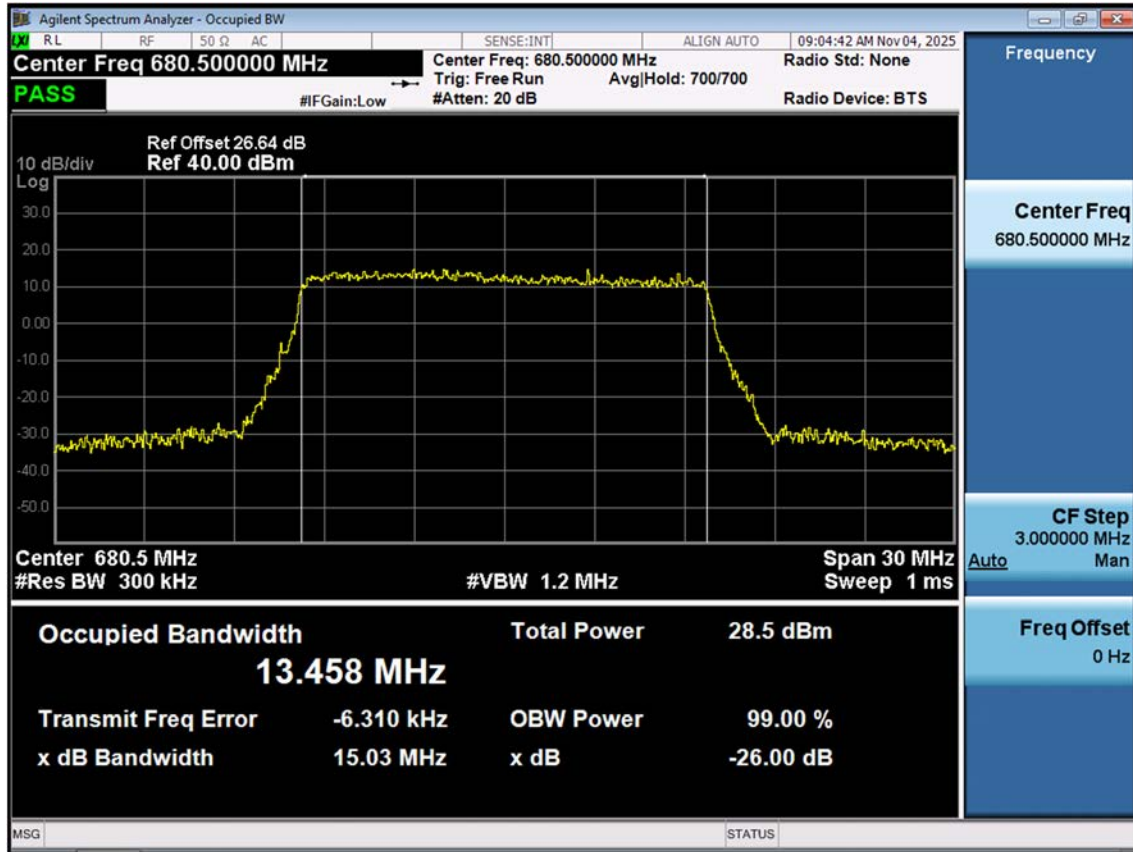
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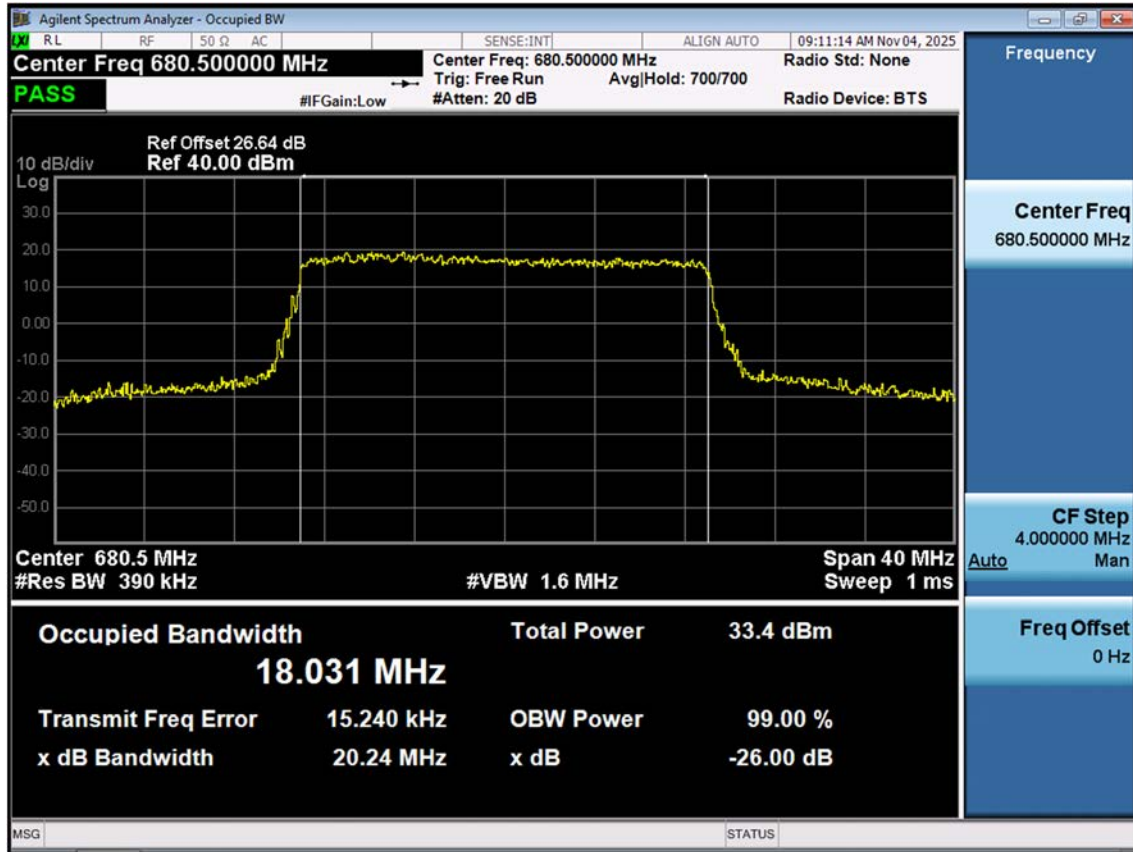
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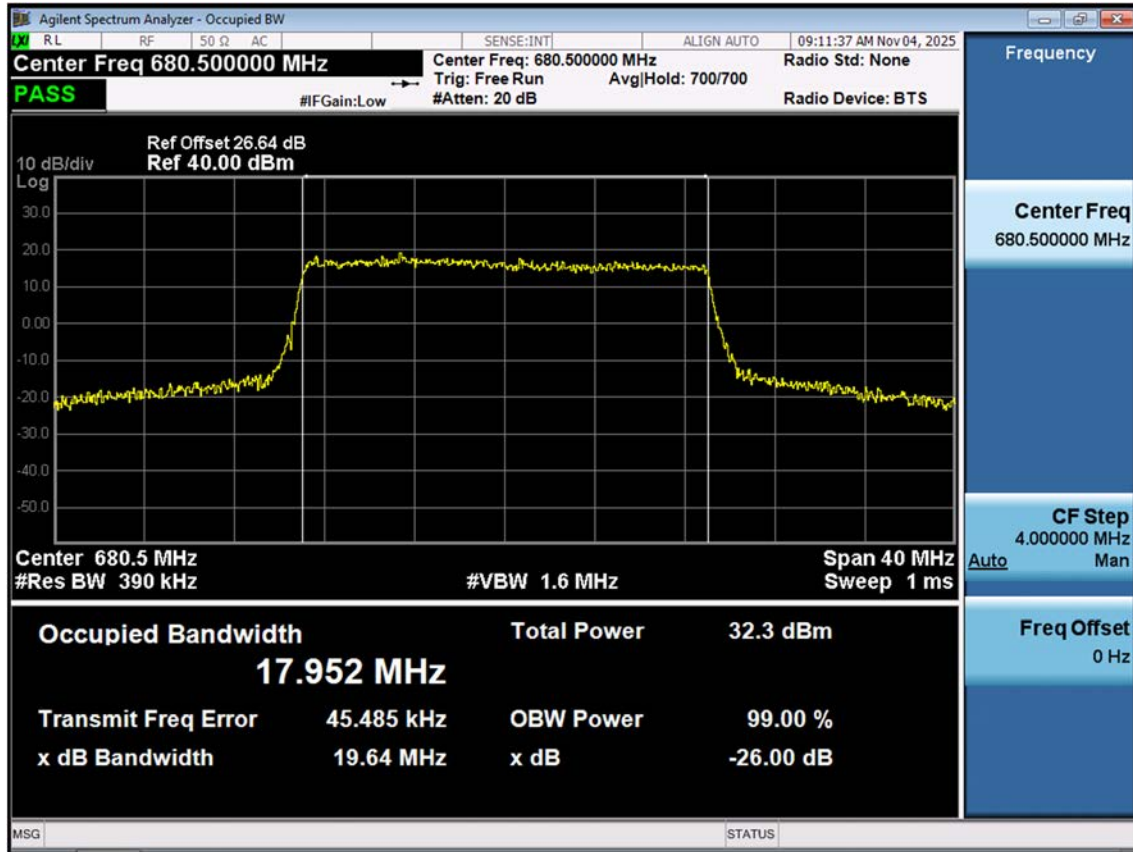
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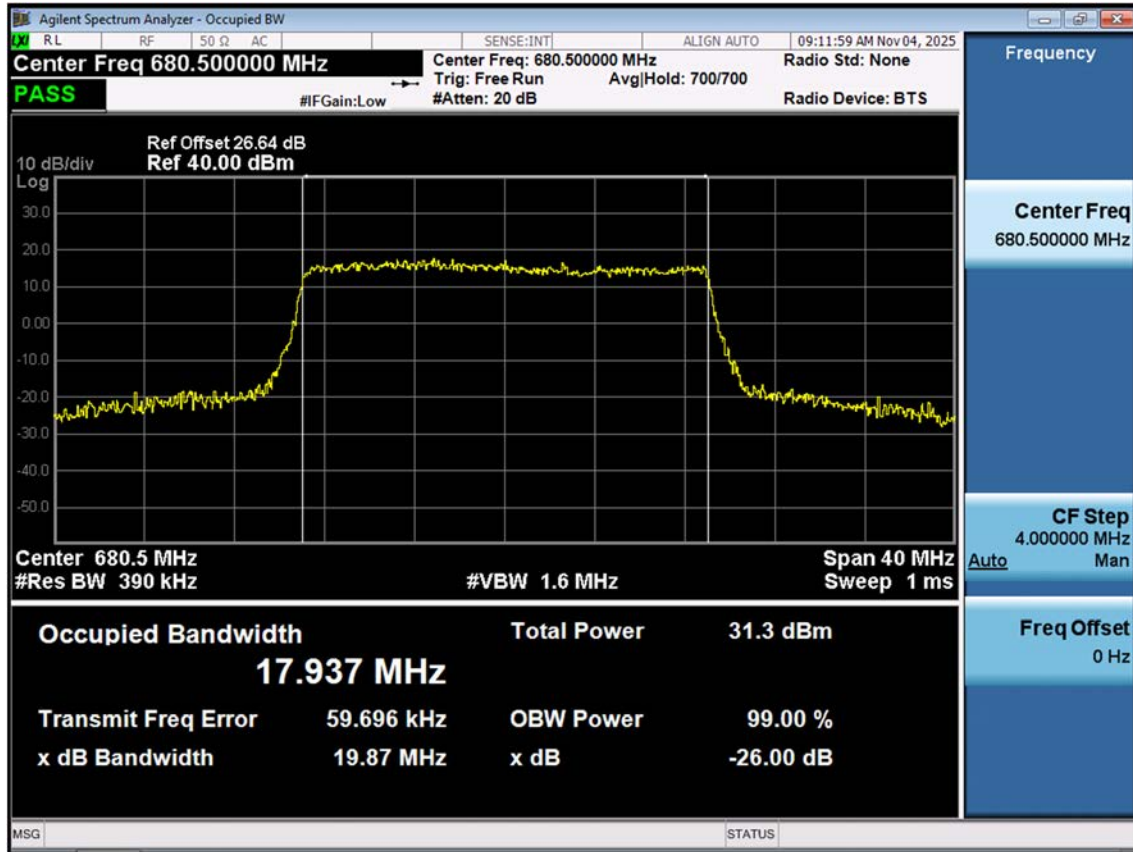
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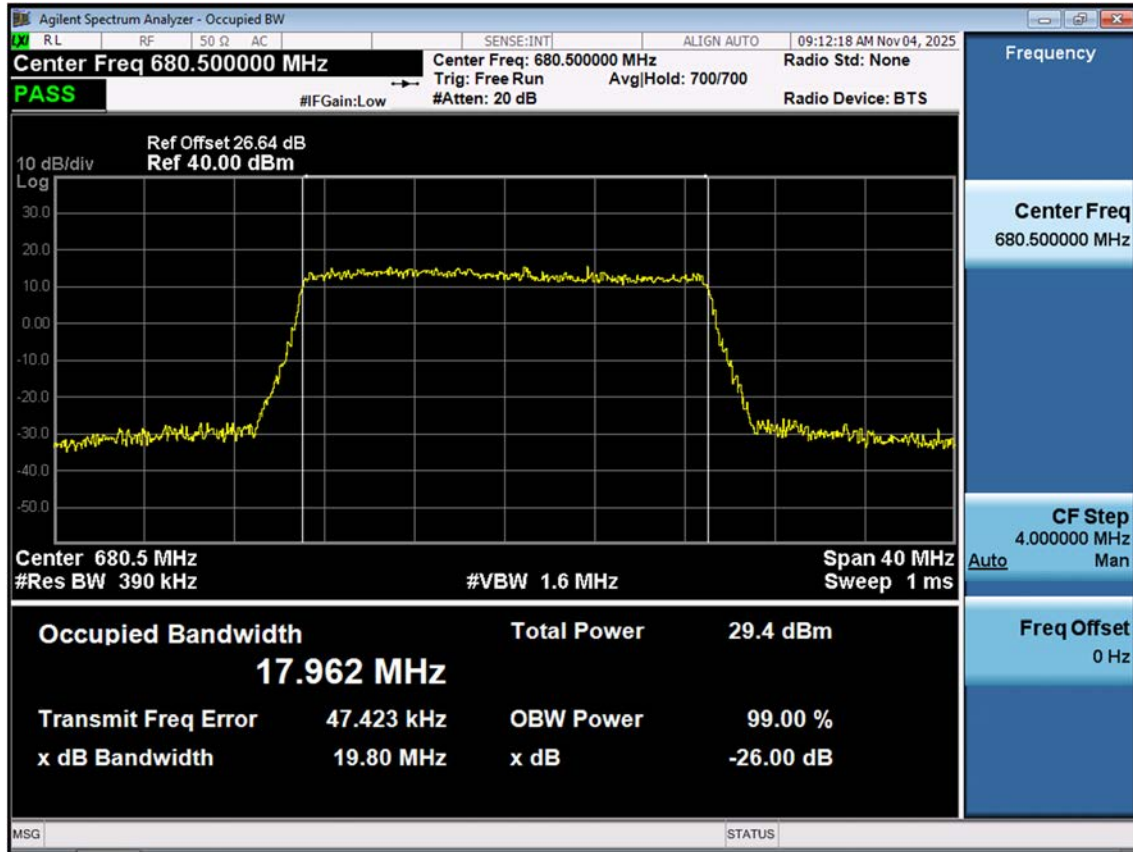
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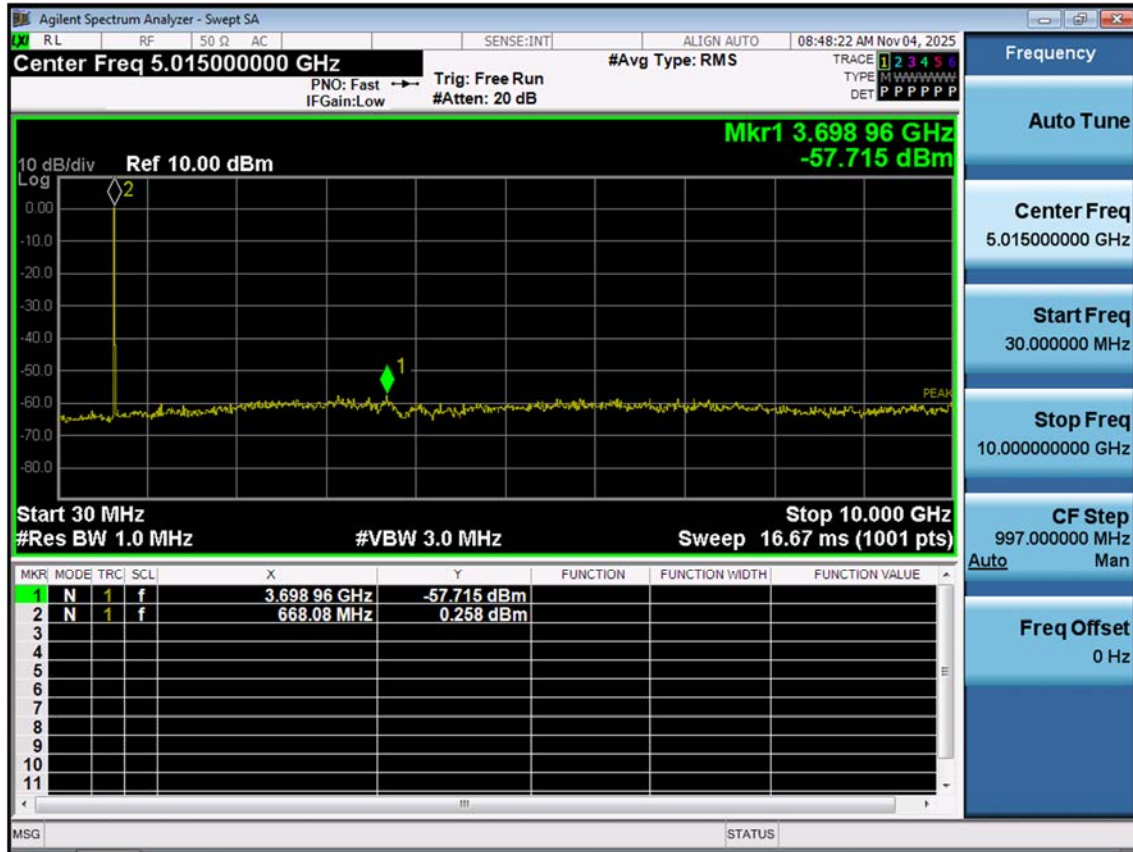
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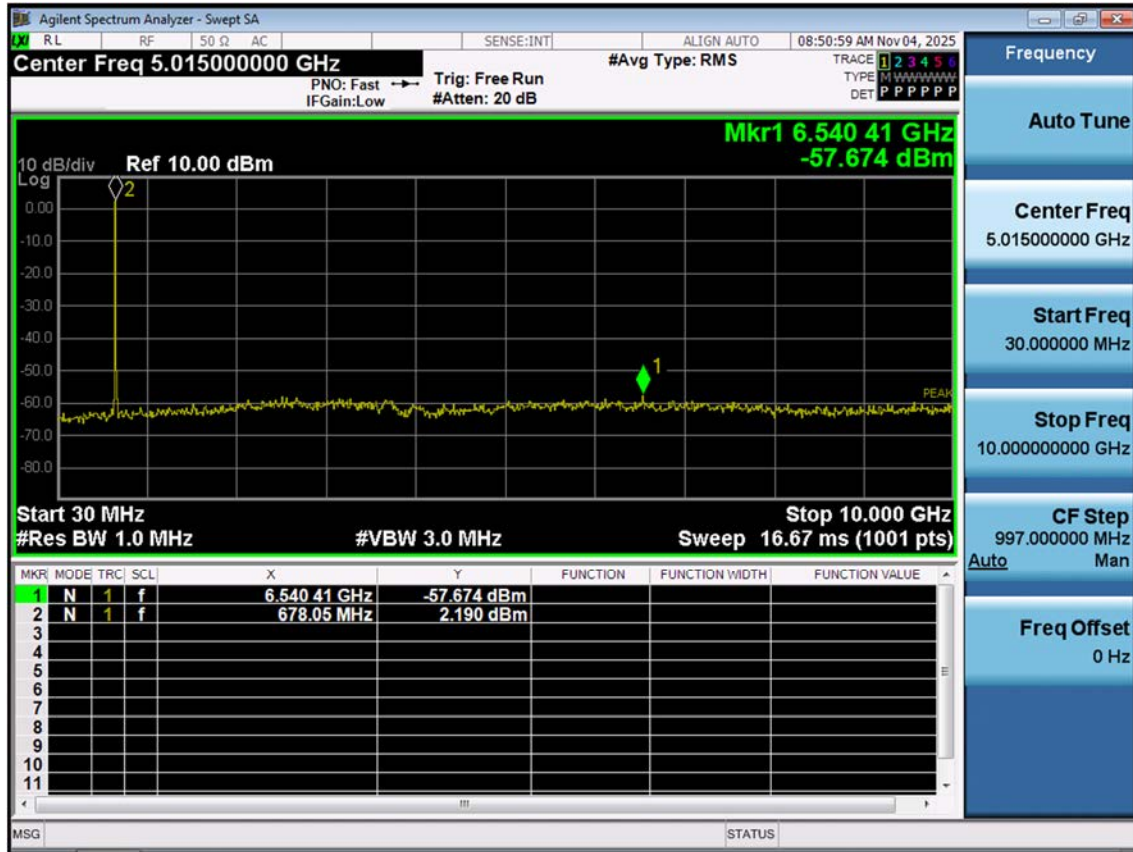
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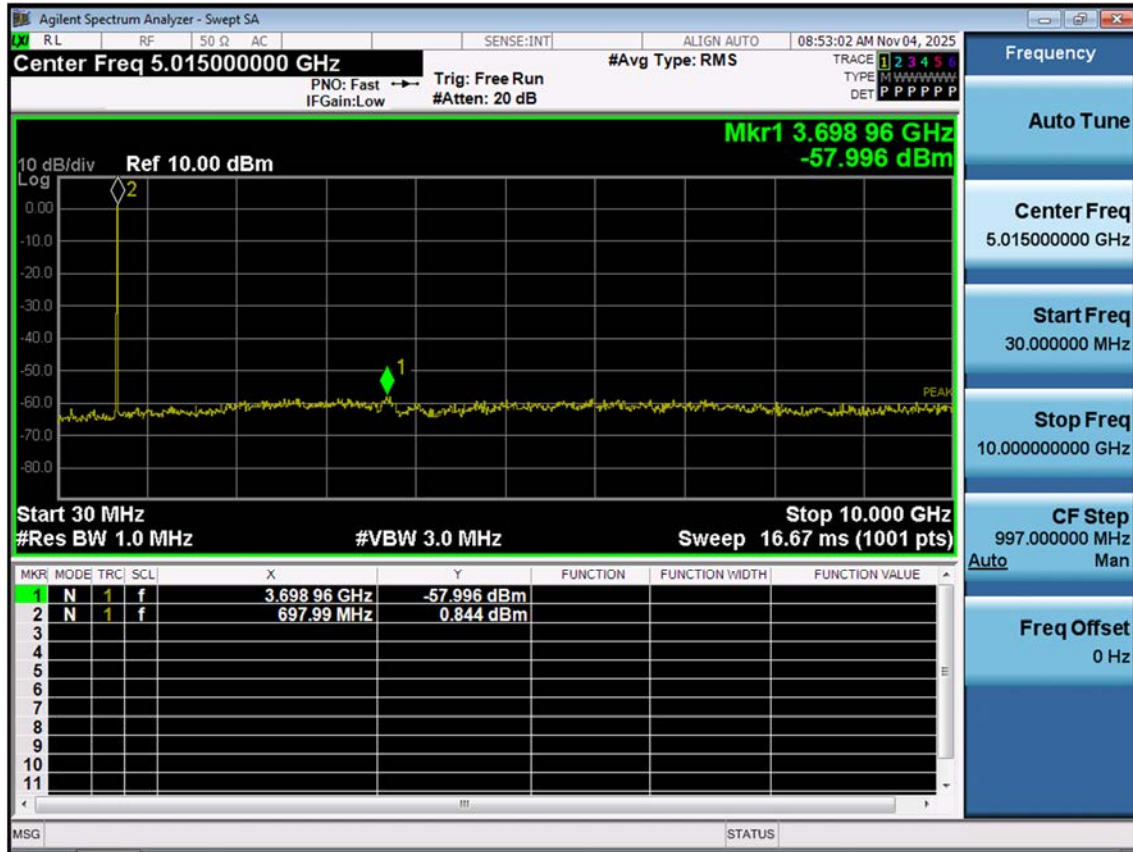
LTE B71_5 M_Conducted Spurious Emissions(30 M-10 G)_Low_QPSK_1RB



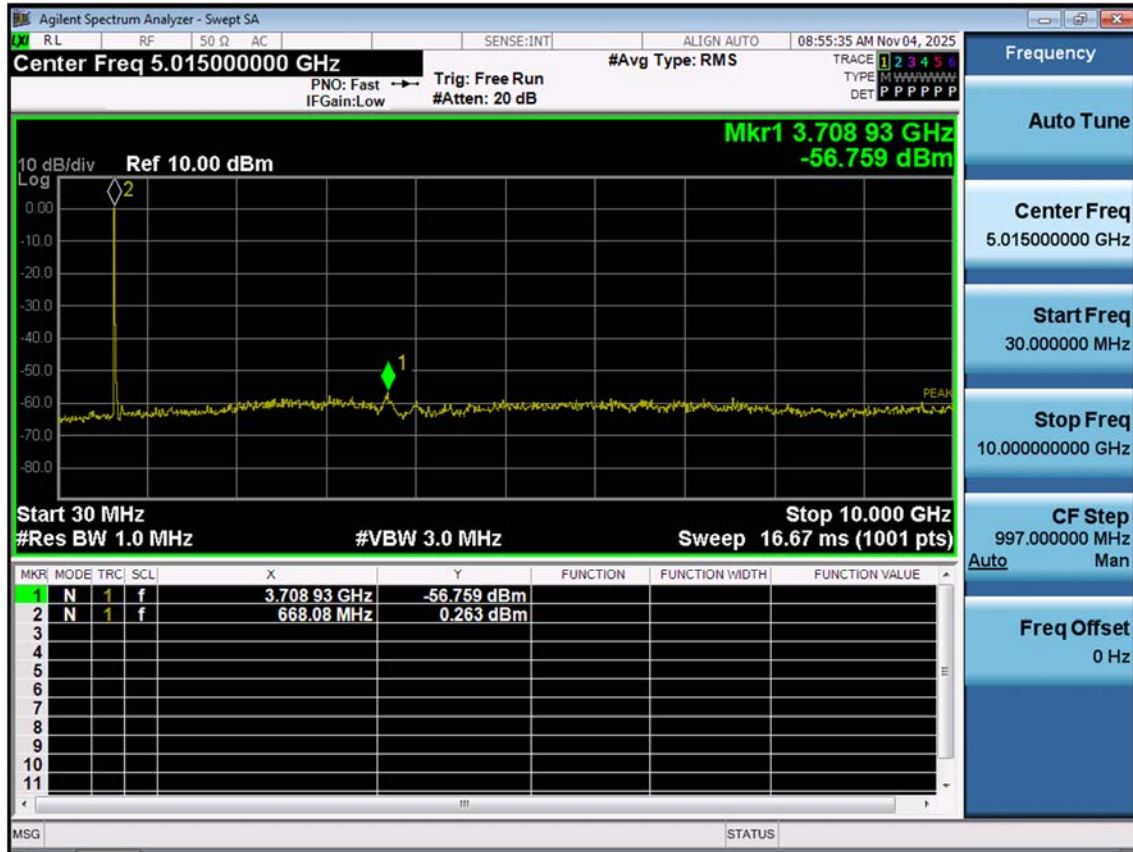
LTE B71_5 M_Conducted Spurious Emissions(30 M-10 G)_Mid_QPSK_1RB



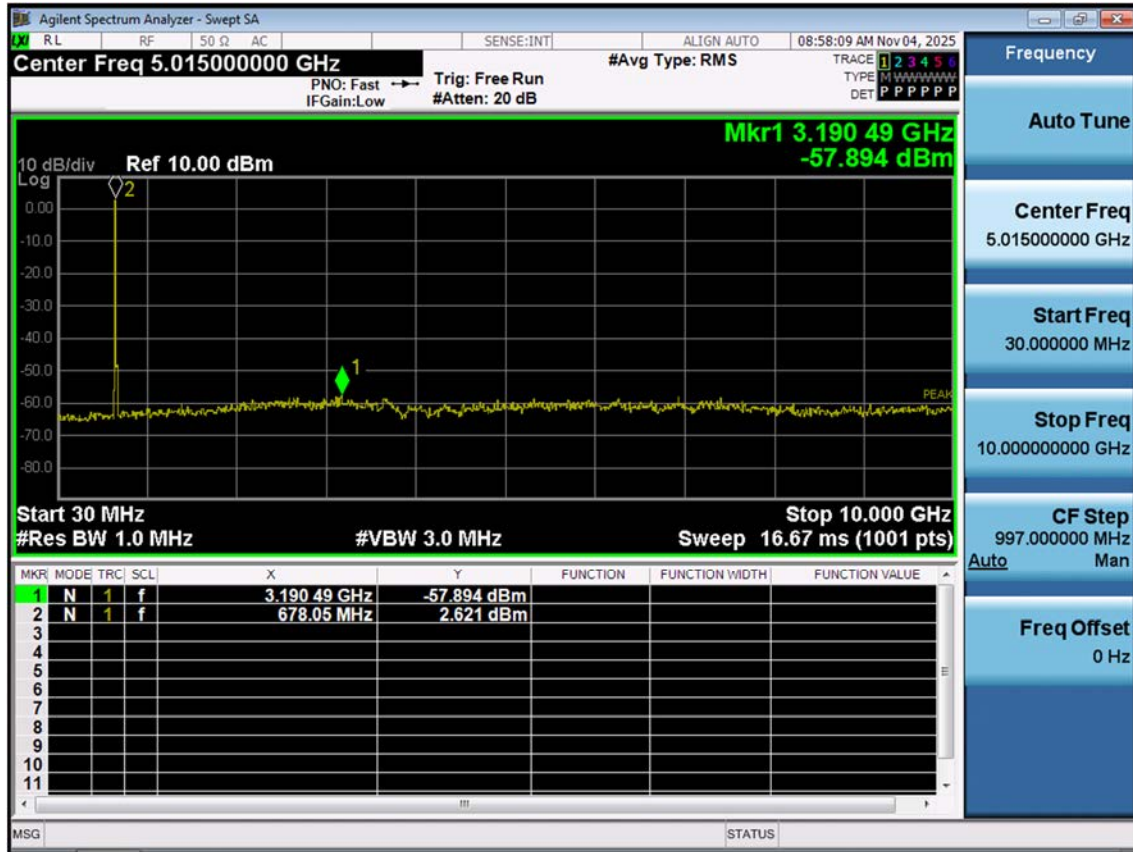
LTE B71_5 M_Conducted Spurious Emissions(30 M-10 G)_High_QPSK_1RB



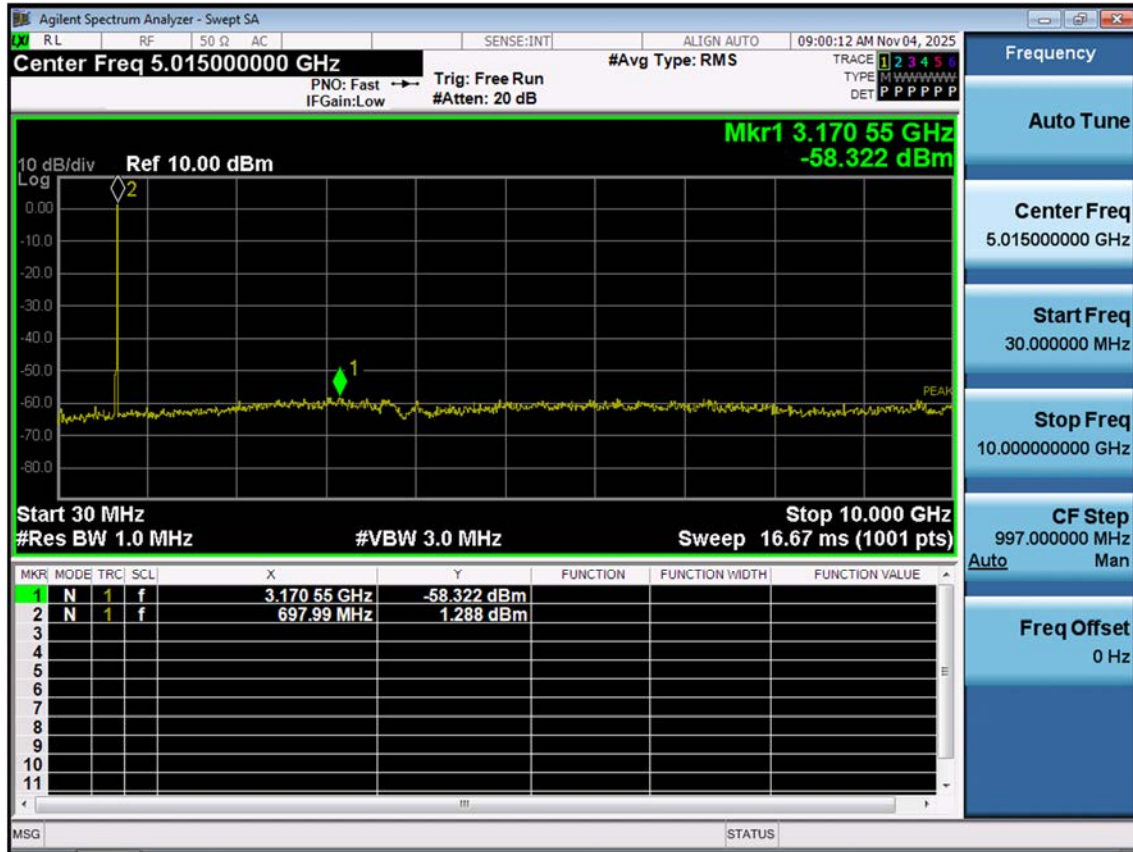
LTE B71_10 M_Conducted Spurious Emissions(30 M-10 G)_Low_QPSK_1RB



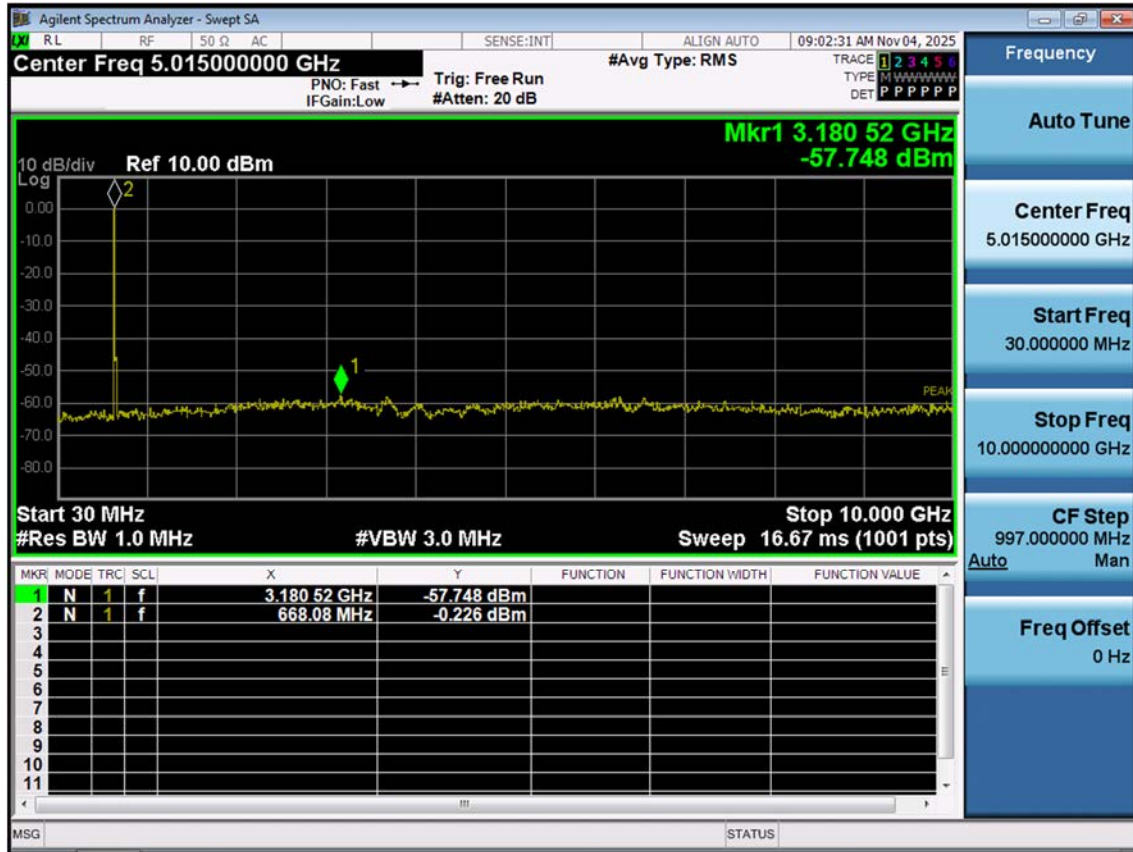
LTE B71_10 M_Conducted Spurious Emissions(30 M-10 G)_Mid_QPSK_1RB



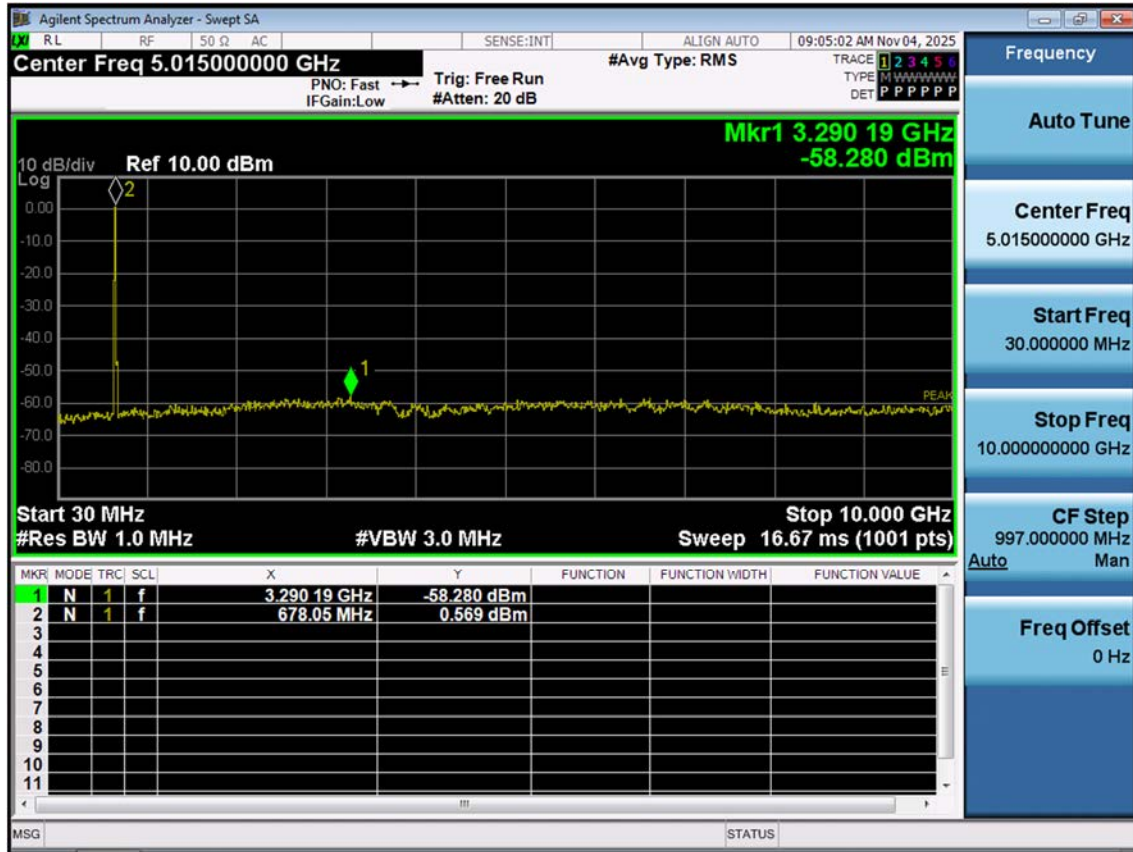
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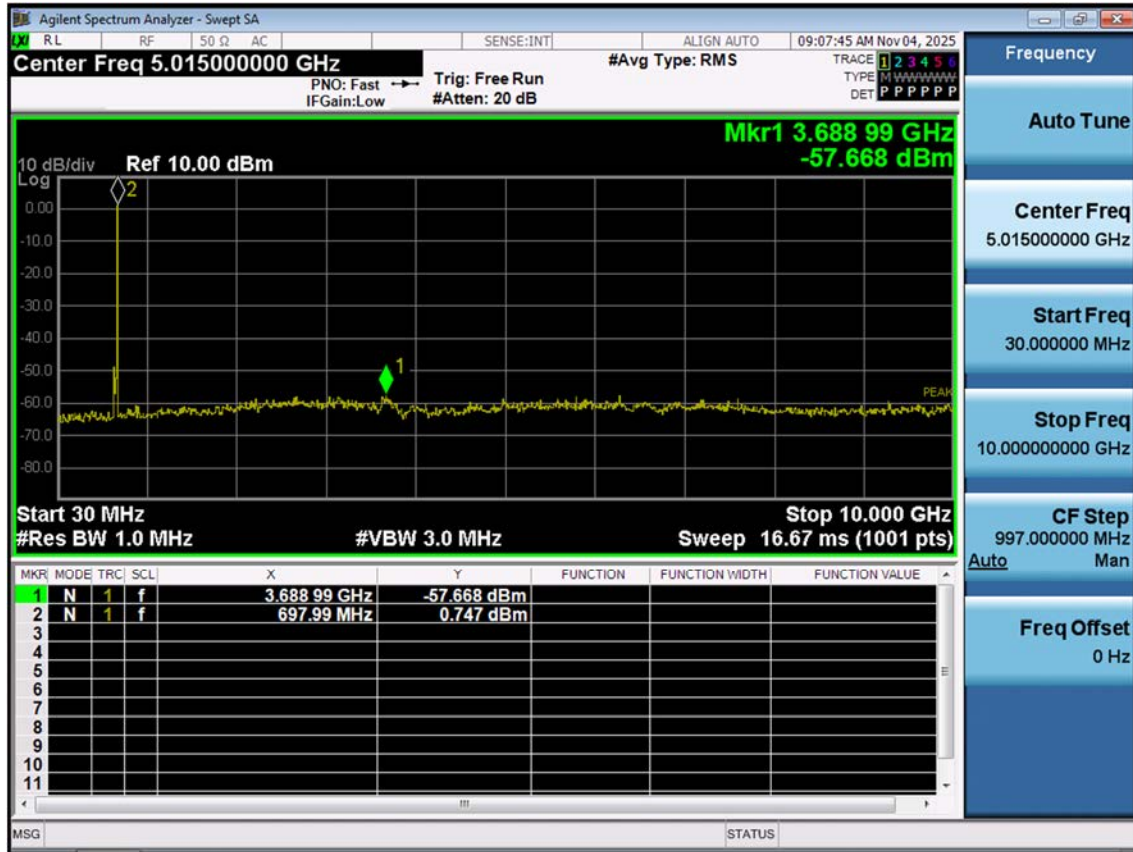
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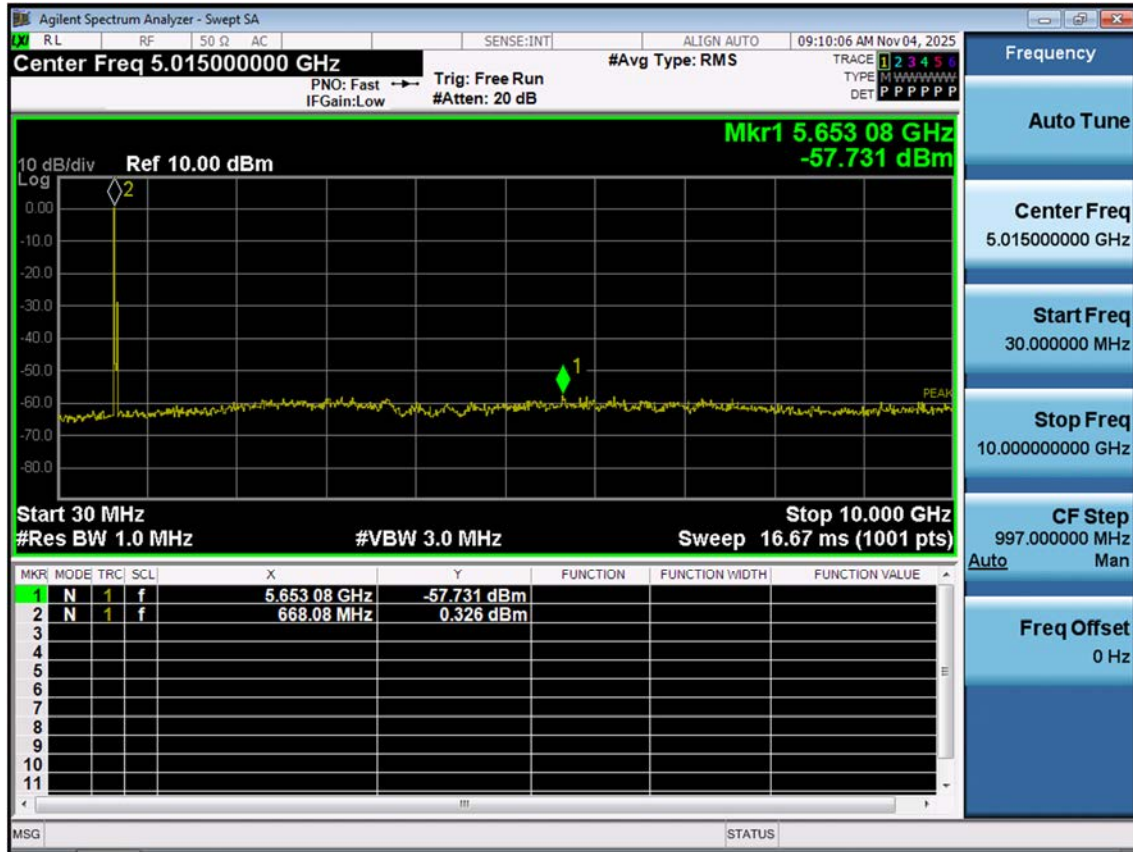
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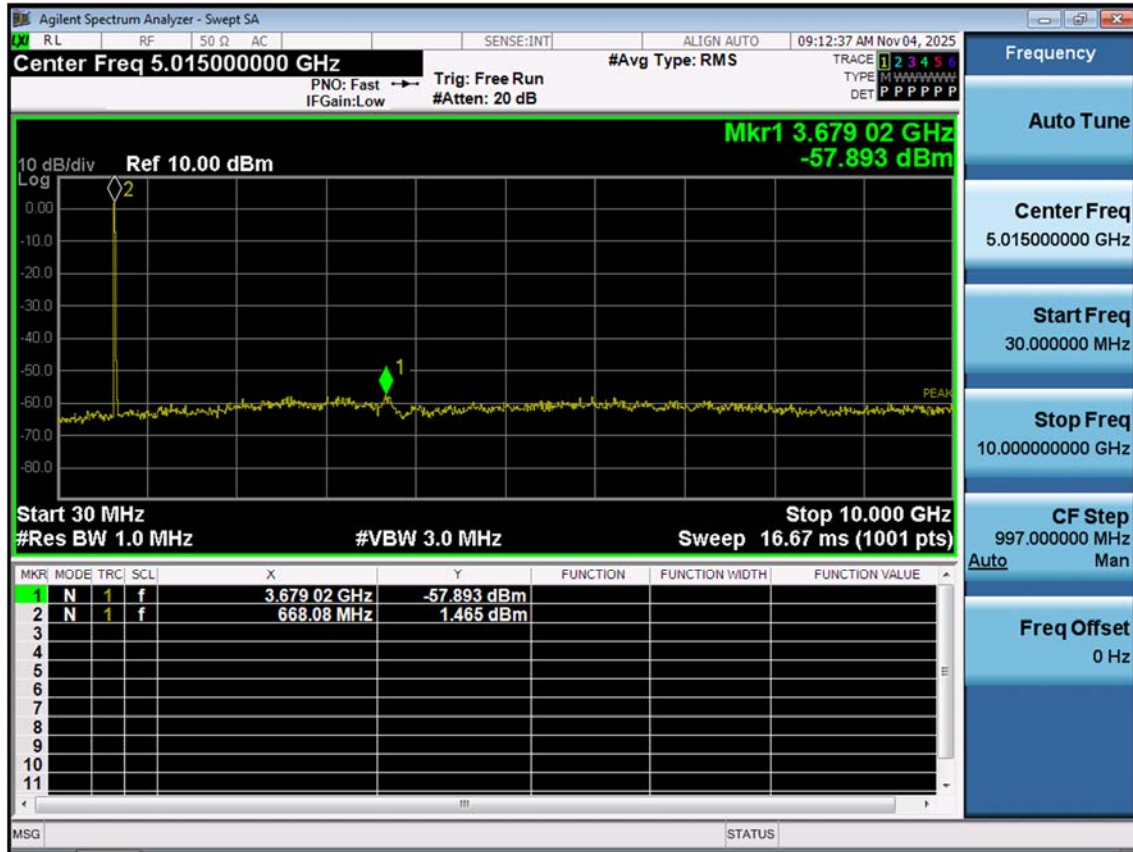
LTE B71_15 M_Conducted Spurious Emissions(30 M-10 G)_High_QPSK_1RB



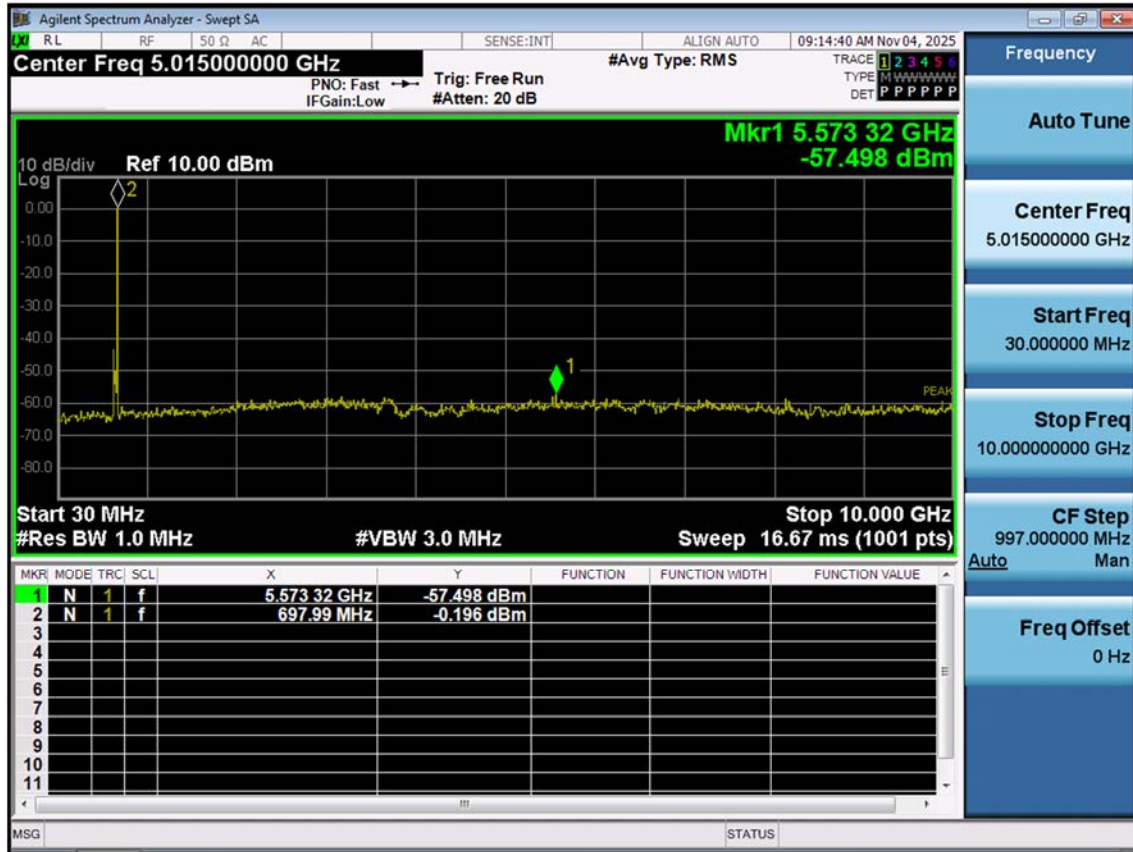
LTE B71_20 M_Conducted Spurious Emissions(30 M-10 G)_Low_QPSK_1RB



LTE B71_20 M_Conducted Spurious Emissions(30 M-10 G)_Mid_QPSK_1RB



LTE B71_20 M_Conducted Spurious Emissions(30 M-10 G)_High_QPSK_1RB



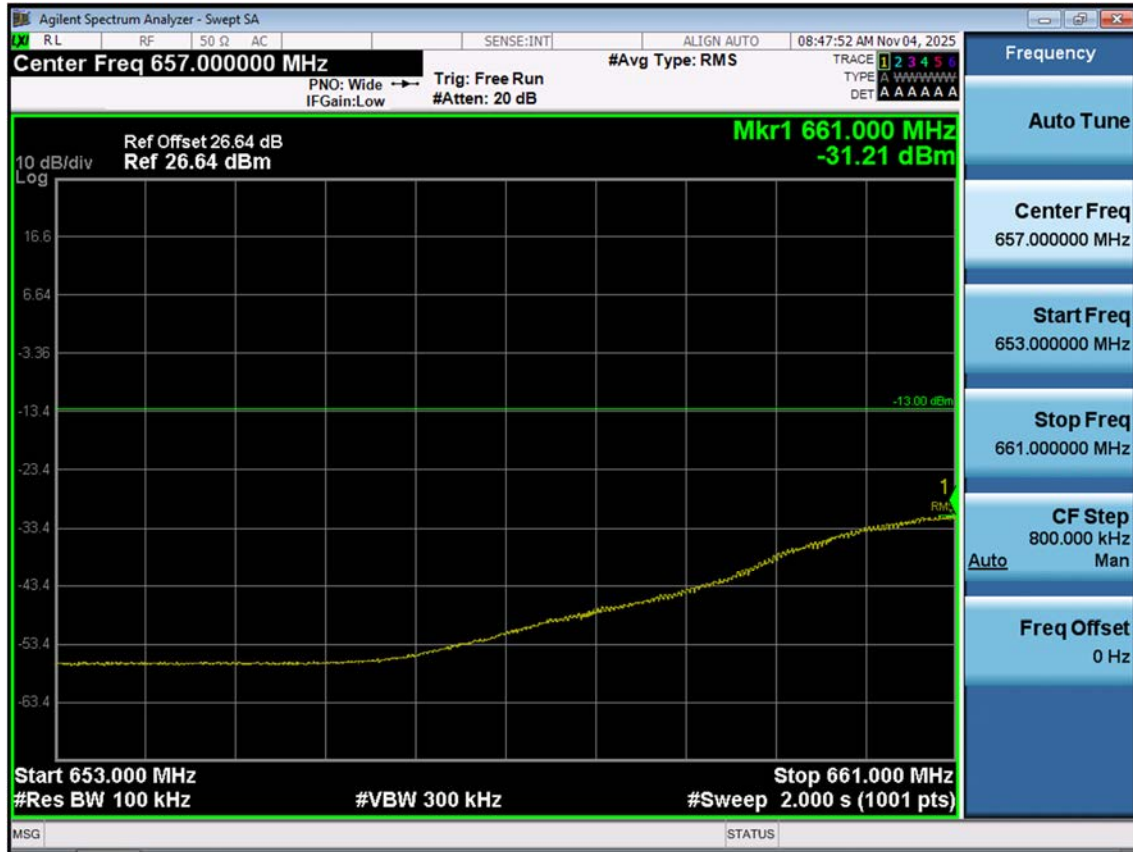
LTE B71_5 M_Channel Edge_Low_QPSK_1RB



LTE B71_5 M_Channel Edge_Low_QPSK_FullRB



LTE B71_5 M_Extended Channel Edge_Low_QPSK_FullRB



LTE B71_5 M_Channel Edge_High_QPSK_1RB



LTE B71_5 M_Channel Edge_High_QPSK_FullRB



LTE B71_5 M_Extended Channel Edge_High_QPSK_FullRB



LTE B71_10 M_Channel Edge_Low_QPSK_1RB



LTE B71_10 M_Channel Edge_Low_QPSK_FullRB







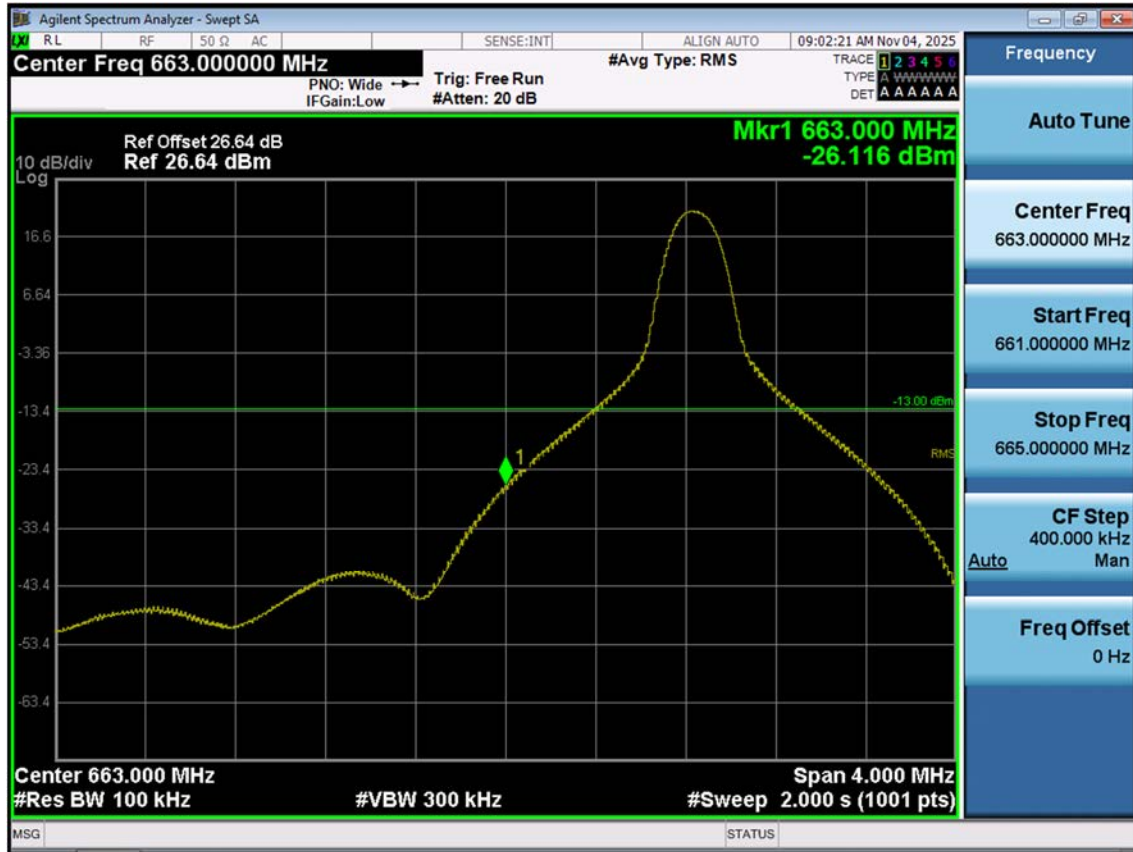
LTE B71_10 M_Channel Edge_High_QPSK_FullRB



LTE B71_10 M_Extended Channel Edge_High_QPSK_FullRB



LTE B71_15 M_Channel Edge_Low_QPSK_1RB



LTE B71_15 M_Channel Edge_Low_QPSK_FullRB





LTE B71_15 M_Channel Edge_High_QPSK_1RB



LTE B71_15 M_Channel Edge_High_QPSK_FullRB



LTE B71_15 M_Extended Channel Edge_High_QPSK_FullRB

